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TEST REPORT

Test report no.: 1-0670/15-01-04

ilac-MRA DAkkS Deutsche Akkreditierungsstelle D-PL-12076-01-00

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Accredited Testing Laboratory:
The testing laboratory (area of testing) is accredited according to DIN EN ISO/IEC 17025 (2005) by the Deutsche Akkreditierungsstelle GmbH (DAkkS)
The accreditation is valid for the scope of testing procedures as stated in the accreditation certificate with the registration number: D-PL-12076-01-00

Applicant

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Manufacturer

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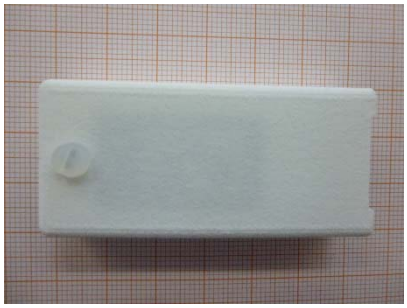
Test standard/s

47 CFR Part 15	Title 47 of the Code of Federal Regulations; Chapter I; Part 15 - Radio frequency devices
RSS - 247 Issue 1	Digital Transmission Systems (DTSs), Frequency Hopping Systems (FHSs) and Licence - Exempt Local Area Network (LE-LAN) Devices

For further applied test standards please refer to section 3 of this test report.

Test Item

Kind of test item:	**ISM-Module**
Model name:	**ISM-Module TruSystem ANY**
FCC ID:	**2AGCQANY2400SC1REV0**
IC:	**20829-0ANY2400SC1**
Frequency:	DTS band 2400 MHz to 2483.5 MHz
Technology tested:	ZigBee
Antenna:	Integrated ceramic chip antenna
Power supply:	3.3 V DC by external power supply
Temperature range:	-10°C to +55°C



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2 General information

2.1 Notes and disclaimer

The test results of this test report relate exclusively to the test item specified in this test report. CETECOM ICT Services GmbH does not assume responsibility for any conclusions and generalizations drawn from the test results with regard to other specimens or samples of the type of the equipment represented by the test item.
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2.2 Application details

Date of receipt of order:	2015-11-24
Date of receipt of test item:	2015-11-23
Start of test:	2015-11-23
End of test:	2015-12-02
Person(s) present during the test:	-/-

3 Test standard/s

Test standard	Date	Test standard description
47 CFR Part 15		Title 47 of the Code of Federal Regulations; Chapter I; Part 15 - Radio frequency devices
RSS - 247 Issue 1	May 2015	Digital Transmission Systems (DTSs), Frequency Hopping Systems (FHSs) and Licence - Exempt Local Area Network (LE-LAN) Devices

3.1 Measurement guidance

Guidance	Version	Description
DTS: KDB 558074 D01	v03r03	Guidance for Performing Compliance Measurements on Digital Transmission Systems (DTS) Operating Under §15.247

4 Test environment

Temperature	:	T_{nom} T_{max} T_{min}	+22 °C during room temperature tests +55 °C during high temperature tests -10 °C during low temperature tests
Relative humidity content	:		55 %
Barometric pressure	:		not relevant for this kind of testing
Power supply	:	V_{nom} V_{max} V_{min}	3.3 V DC by external power supply 3.6 V 1.8 V

5 Test item

5.1 General description

Kind of test item	:	ISM-Module
Type identification	:	ISM-Module TruSystem ANY
HMN	:	-/-
PMN	:	ISM-Module TruSystem ANY
HVIN	:	REV00
FVIN	:	-/-
S/N serial number	:	Rad. 36345757200054 Cond. 36345757200065
HW hardware status	:	REV00
SW software status	:	2.5.1.0
Frequency band	:	DTS band 2400 MHz to 2483.5 MHz (lowest channel 2405 MHz; highest channel 2480 MHz)
Type of radio transmission Use of frequency spectrum	: :	DSSS
Type of modulation	:	O-QPSK
Number of channels	:	16
Antenna	:	Integrated ceramic chip antenna
Power supply	:	3.3 V DC by external power supply
Temperature range	:	-10°C to +55°C

5.2 Additional information

The content of the following annexes is defined in the QA. It may be that not all of the listed annexes are necessary for this report, thus some values in between may be missing.

Test setup- and EUT-photos are included in test report: 1-0670_15-01-01_AnnexA
1-0670_15-01-01_AnnexB
1-0670_15-01-01_AnnexD

6 Test laboratories sub-contracted

None

7 Description of the test setup

Typically, the calibrations of the test apparatus are commissioned to and performed by an accredited calibration laboratory. The calibration intervals are determined in accordance with the DIN EN ISO/IEC 17025. In addition to the external calibrations, the laboratory executes comparison measurements with other calibrated test systems or effective verifications. Weekly chamber inspections and range calibrations are performed. Where possible, RF generating and signaling equipment as well as measuring receivers and analyzers are connected to an external high-precision 10 MHz reference (GPS-based or rubidium frequency standard).

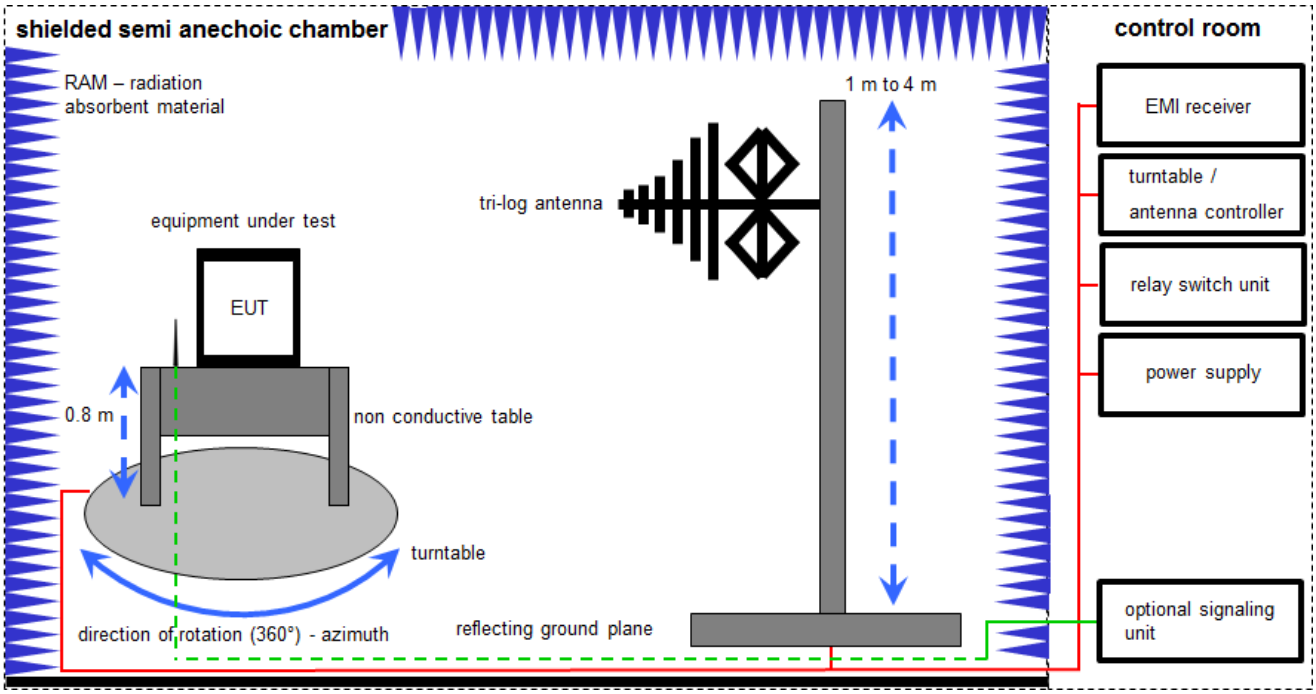
In order to simplify the identification of the equipment used at some special tests, some items of test equipment and ancillaries can be provided with an identifier or number in the equipment list below (Lab/Item).

Agenda: Kind of Calibration

k	calibration / calibrated	EK	limited calibration
ne	not required (k, ev, izw, zw not required)	zw	cyclical maintenance (external cyclical maintenance)
ev	periodic self verification	izw	internal cyclical maintenance
Ve	long-term stability recognized	g	blocked for accredited testing
vlkl!	Attention: extended calibration interval		
NK!	Attention: not calibrated	*)	next calibration ordered / currently in progress

7.1 Shielded semi anechoic chamber

The radiated measurements are performed in vertical and horizontal plane in the frequency range from 9 kHz to 1 GHz in semi-anechoic chambers. The EUT is positioned on a non-conductive support with a height of 0.80 m above a conductive ground plane that covers the whole chamber. The receiving antennas are confirmed with specifications ANSI C63. These antennas can be moved over the height range between 1.0 m and 4.0 m in order to search for maximum field strength emitted from EUT. The measurement distances between EUT and receiving antennas are indicated in the test setups for the various frequency ranges. For each measurement, the EUT is rotated in all three axes until the maximum field strength is received. The wanted and unwanted emissions are received by spectrum analyzers where the detector modes and resolution bandwidths over various frequency ranges are set according to requirement ANSI C63.



Measurement distance: tri-log antenna 10 meter

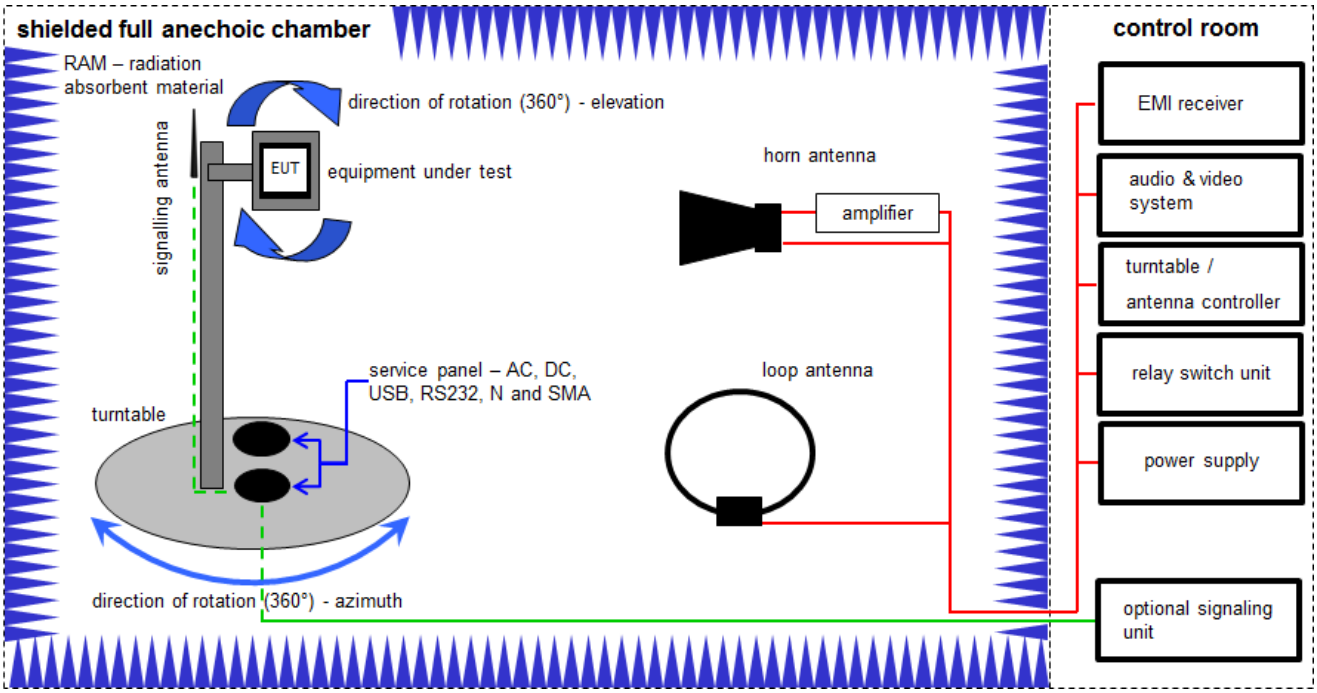
FS = UR + CL + AF
(FS-field strength; UR-voltage at the receiver; CL-loss of the cable; AF-antenna factor)

Example calculation:
FS [dBµV/m] = 12.35 [dBµV/m] + 1.90 [dB] + 16.80 [dB/m] = 31.05 [dBµV/m] (35.69 µV/m)

Equipment table:

No.	Lab / Item	Equipment	Type	Manufact.	Serial No.	INV. No Cetecom	Kind of Calibration	Last Calibration	Next Calibration
1	A	Switch-Unit	3488A	HP	2719A14505	300000368	ev	-/-	-/-
2	A	DC power supply, 60Vdc, 50A, 1200 W	6032A	HP	2920A04466	300000580	ne	-/-	-/-
3	A	software	SPS_PHE 1.4f	Spitzenberger & Spiess	B5981; 5D1081;B5979	300000210	ne	-/-	-/-
4	A	EMI Test Receiver	ESCI 3	R&S	100083	300003312	k	26.01.2015	26.01.2016
5	A	Analyzer-Reference-System (Harmonics and Flicker)	ARS 16/1	SPS	A3509 07/0 0205	300003314	Ve	11.02.2014	11.02.2016
6	A	Amplifier	JS42-00502650-28-5A	MITEQ	1084532	300003379	ev	-/-	-/-
7	A	Antenna Tower	Model 2175	ETS-Lindgren	64762	300003745	izw	-/-	-/-
8	A	Positioning Controller	Model 2090	ETS-Lindgren	64672	300003746	izw	-/-	-/-
9	A	Turntable Interface-Box	Model 105637	ETS-Lindgren	44583	300003747	izw	-/-	-/-
10	A	TRILOG Broadband Test-Antenna 30 MHz - 3 GHz	VULB9163	Schwarzbeck	295	300003787	k	22.04.2014	22.04.2016

7.2 Shielded fully anechoic chamber



Measurement distance: horn antenna 3 meter; loop antenna 3 meter

FS = UR + CA + AF
(FS-field strength; UR-voltage at the receiver; CA-loss of the signal path; AF-antenna factor)

Example calculation:
FS [dBµV/m] = 40.0 [dBµV/m] + (-35.8) [dB] + 32.9 [dB/m] = 37.1 [dBµV/m] (71.61 µV/m)

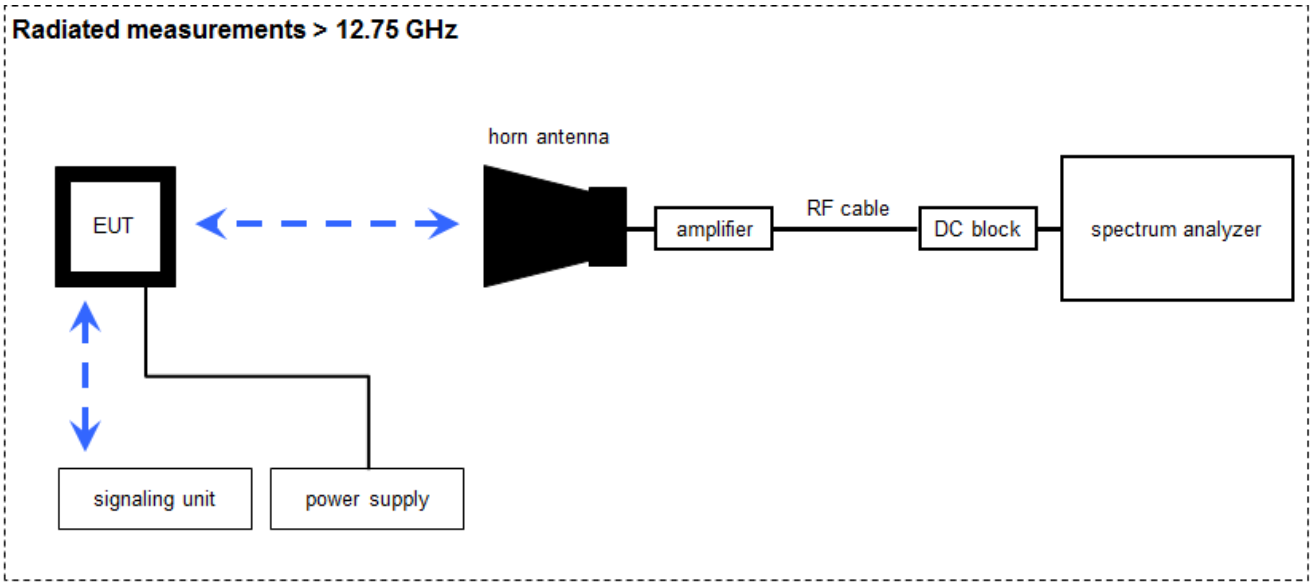
OP = AV + D - G + CA
(OP-radiated output power; AV-analyzer value; D-free field attenuation of measurement distance; G-antenna gain+amplifier gain; CA-loss signal path)

Example calculation:
OP [dBm] = -39.0 [dBm] + 57.0 [dB] - 12.0 [dBi] + (-36.0) [dB] = -30 [dBm] (1 µW)

Equipment table:

No.	Lab / Item	Equipment	Type	Manufact.	Serial No.	INV. No Cetecom	Kind of Calibration	Last Calibration	Next Calibration
1	A, B, C	DC power supply, 60Vdc, 50A, 1200 W	6032A	HP	2818A03450	300001040	Ve	20.01.2015	20.01.2018
2	A	Double-Ridged Waveguide Horn Antenna 1-18.0GHz	3115	EMCO	8812-3088	300001032	vIKI!	20.05.2015	20.05.2017
3	A, B, C	Anechoic chamber	FAC 3/5m	MWB / TDK	87400/02	300000996	ev	-/-	-/-
4	A, B, C	Switch / Control Unit	3488A	HP	*	300000199	ne	-/-	-/-
5	C	Active Loop Antenna 10 kHz to 30 MHz	6502	EMCO/2	8905-2342	300000256	k	24.06.2015	24.06.2017
6	A	Amplifier	js42-00502650-28-5a	Parzich GMBH	928979	300003143	ne	-/-	-/-
7	A	Band Reject filter	WRCG2400/2483-2375/2505-50/10SS	Wainwright	11	300003351	ev	-/-	-/-
8	A	Highpass Filter	WHKX7.0/18G-8SS	Wainwright	18	300003789	ne	-/-	-/-
9	A, B, C	4U RF Switch Platform	L4491A	Agilent Technologies	MY50000037	300004509	ne	-/-	-/-
10	A, B, C	EMI Test Receiver 20Hz- 26,5GHz	ESU26	R&S	100037	300003555	k	22.01.2015	22.01.2016

7.3 Radiated measurements > 12.75 GHz



Measurement distance: horn antenna 50 cm

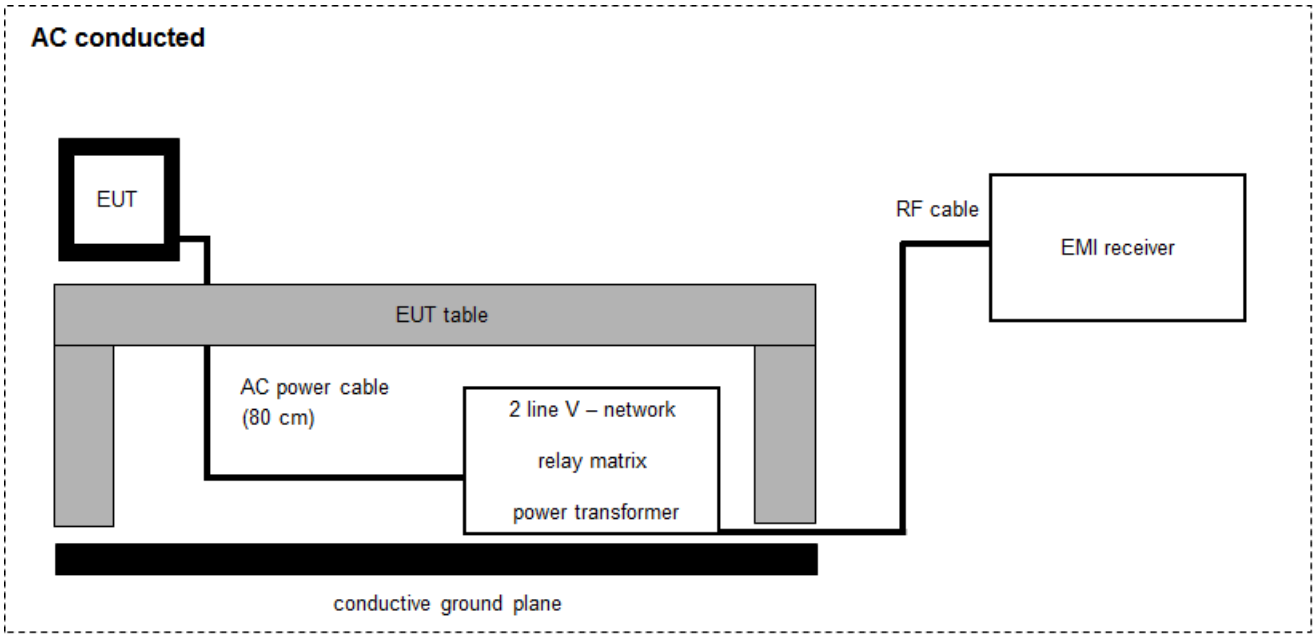
FS = U_R + CA + AF
(FS-field strength; U_R-voltage at the receiver; CA-loss signal path & distance correction; AF-antenna factor)

Example calculation:
FS [dBµV/m] = 40.0 [dBµV/m] + (-60.1) [dB] + 36.74 [dB/m] = 16.64 [dBµV/m] (6.79 µV/m)

Equipment table:

No.	Lab / Item	Equipment	Type	Manufact.	Serial No.	INV. No Cetecom	Kind of Calibration	Last Calibration	Next Calibration
1	A	Signal Analyzer 40 GHz	FSV40	R&S	101042	300004517	k	22.01.2015	22.01.2016
2	A	Power Supply 0-20V, 0-5A	6632B	Agilent Technologies	GB42110541	400000562	vIKI!	10.01.2013	10.01.2016
3	A	Amplifier 2-40 GHz	JS32-02004000-57-5P	MITEQ	1777200	300004541	ev	-/-	-/-
4	A	RF-Cable	ST18/SMAm/SMAm/60	Huber & Suhner	Batch no. 606844	400001181	ev	-/-	-/-
5	A	RF-Cable	ST18/SMAm/SMAm/48	Huber & Suhner	Batch no. 600918	400001182	ev	-/-	-/-
6	A	DC-Blocker 0.1-40 GHz	8141A	Inmet	Batch no. 600918	400001185	ev	-/-	-/-
7	A	Std. Gain Horn Antenna 12.4 to 18.0 GHz	639	Narda	8402	300000787	k	14.08.2015	14.08.2017
8	A	Std. Gain Horn Antenna 18.0 to 26.5 GHz	638	Narda	8205	300002442	NK!	19.07.2013	-/-

7.4 AC conducted



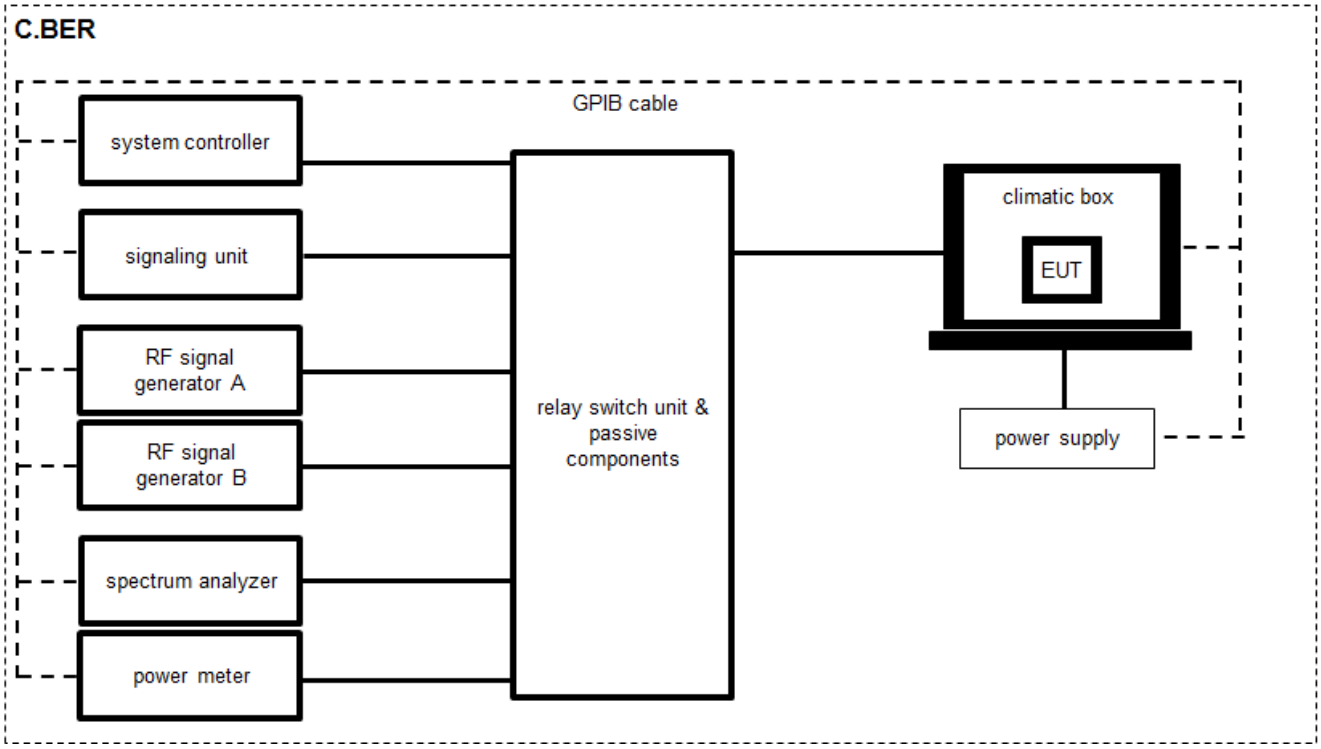
FS = UR + CF + VC
(FS-field strength; UR-voltage at the receiver; CR-loss of the cable and filter; VC-correction factor of the ISN)

Example calculation:
FS [dBµV/m] = 37.62 [dBµV/m] + 9.90 [dB] + 0.23 [dB] = 47.75 [dBµV/m] (244.06 µV/m)

Equipment table:

No.	Lab / Item	Equipment	Type	Manufact.	Serial No.	INV. No Cetecom	Kind of Calibration	Last Calibration	Next Calibration
1	A	Netznachbildung	ESH3-Z5	R&S	892475/017	300002209	k	17.06.2014	17.06.2016
2	A	EMI-Receiver	8542E	HP	3617A00170	300000568	k	28.01.2015	28.01.2016
3	A	Analyzer-Reference-System (Harmonics and Flicker)	ARS 16/1	SPS	A3509 07/0 0205	300003314	Ve	11.02.2014	11.02.2016

7.5 Conducted measurements C.BER system



OP = AV + CA
(OP-output power; AV-analyzer value; CA-loss signal path)

Example calculation:
OP [dBm] = 6.0 [dBm] + 11.7 [dB] = 17.7 [dBm] (58.88 mW)

Equipment table:

No.	Lab / Item	Equipment	Type	Manufact.	Serial No.	INV. No Cetecom	Kind of Calibration	Last Calibration	Next Calibration
1	A	Switch / Control Unit	3488A	HP		300001691	ne	-/-	-/-
2	A	Power Supply DC	NGPE 40/40	R&S	388	400000078	vlKl!	22.01.2015	22.01.2017
7	A	Signal Analyzer 20Hz-26,5GHz-150 to + 30 DBM	FSIQ26	R&S	835540/018	300002681	k	30.01.2014	30.01.2016
8	A	Frequency Standard (Rubidium Frequency Standard)	MFS (Rubidium)	R&S (Datum)	002	300002681	Ve	29.01.2015	29.01.2017
10	A	Directional Coupler	101020010	Krytar	70215	300002840	ev	-/-	-/-
11	A	DC-Blocker	8143	Inmet Corp.	none	300002842	ne	-/-	-/-
12	A	Powersplitter	6005-3	Inmet Corp.	none	300002841	ev	-/-	-/-
21	A	RF-Cable	ST18/SMAm/SMAm/ 72	Huber & Suhner	Batch no. 605505	400001187	ev	-/-	-/-
22	A	RF-Cable	Sucoflex 104	Huber & Suhner	147636/4	400001188	ev	-/-	-/-

8 Sequence of testing

8.1 Sequence of testing radiated spurious 9 kHz to 30 MHz

Setup

- The equipment is set up to simulate normal operation mode as described in the user manual or defined by the manufacturer.
- If the EUT is a tabletop system, a 2-axis positioner with 1.5 m height is used.
- If the EUT is a floor standing device, it is placed directly on the turn table.
- Auxiliary equipment and cables are positioned to simulate normal operation conditions as described in ANSI C 63.4.
- The AC power port of the EUT (if available) is connected to a power outlet below the turntable.
- Measurement distance is 3 m (see ANSI C 63.4) – see test details.
- EUT is set into operation.

Premeasurement

- The turntable rotates from 0° to 315° using 45° steps.
- The antenna height is 1.5 m.
- At each turntable position the analyzer sweeps with positive-peak detector to find the maximum of all emissions.

Final measurement

- Identified emissions during the premeasurement are maximized by the software by rotating the turntable from 0° to 360°. In case of the 2-axis positioner is used the elevation axis is also rotated from 0° to 360°.
- The final measurement is done in the position (turntable and elevation) causing the highest emissions with quasi-peak (as described in ANSI C 63.4).
- Final levels, frequency, measuring time, bandwidth, turntable position, correction factor, margin to the limit and limit will be recorded. A plot with the graph of the premeasurement and the limit is stored.

8.2 Sequence of testing radiated spurious 30 MHz to 1 GHz

Setup

- The equipment is set up to simulate normal operation mode as described in the user manual or defined by the manufacturer.
- If the EUT is a tabletop system, a table with 0.8 m height is used, which is placed on the ground plane.
- If the EUT is a floor standing device, it is placed on the ground plane with insulation between both.
- Auxiliary equipment and cables are positioned to simulate normal operation conditions as described in ANSI C 63.4.
- The AC power port of the EUT (if available) is connected to a power outlet below the turntable.
- Measurement distance is 10 m or 3 m (see ANSI C 63.4) – see test details.
- EUT is set into operation.

Premeasurement

- The turntable rotates from 0° to 315° using 45° steps.
- The antenna is polarized vertical and horizontal.
- The antenna height changes from 1 m to 3 m.
- At each turntable position, antenna polarization and height the analyzer sweeps three times in peak to find the maximum of all emissions.

Final measurement

- The final measurement is performed for at least six highest peaks according to the requirements of the ANSI C63.4.
- Based on antenna and turntable positions at which the peak values are measured the software maximize the peaks by changing turntable position ± 45° and antenna height between 1 and 4 m.
- The final measurement is done with quasi-peak detector (as described in ANSI C 63.4).
- Final levels, frequency, measuring time, bandwidth, antenna height, antenna polarization, turntable angle, correction factor, margin to the limit and limit are recorded. A plot with the graph of the premeasurement with marked maximum final results and the limit is stored.

8.3 Sequence of testing radiated spurious 1 GHz to 12.75 GHz

Setup

- The equipment is set up to simulate normal operation mode as described in the user manual or defined by the manufacturer.
- If the EUT is a tabletop system, a 2-axis positioner with 1.5 m height is used.
- If the EUT is a floor standing device, it is placed directly on the turn table.
- Auxiliary equipment and cables are positioned to simulate normal operation conditions as described in ANSI C 63.4.
- The AC power port of the EUT (if available) is connected to a power outlet below the turntable.
- Measurement distance is 3 m (see ANSI C 63.4) – see test details.
- EUT is set into operation.

Premeasurement

- The turntable rotates from 0° to 315° using 45° steps.
- The antenna is polarized vertical and horizontal.
- The antenna height is 1.5 m.
- At each turntable position and antenna polarization the analyzer sweeps with positive peak detector to find the maximum of all emissions.

Final measurement

- The final measurement is performed for at least six highest peaks according to the requirements of the ANSI C63.4.
- Based on antenna and turntable positions at which the peak values are measured the software maximizes the peaks by rotating the turntable from 0° to 360°. This measurement is repeated for different EUT-table positions (0° to 150° in 30°-steps) and for both antenna polarizations.
- The final measurement is done in the position (turntable, EUT-table and antenna polarization) causing the highest emissions with Peak and RMS detector (as described in ANSI C 63.4).
- Final levels, frequency, measuring time, bandwidth, turntable position, EUT-table position, antenna polarization, correction factor, margin to the limit and limit are recorded. A plot with the graph of the premeasurement with marked maximum final results and the limit is stored.

8.4 Sequence of testing radiated spurious above 12.75 GHz

Setup

- The equipment is set up to simulate normal operation mode as described in the user manual or defined by the manufacturer.
- Auxiliary equipment and cables are positioned to simulate normal operation conditions as described in ANSI C 63.4.
- The AC power port of the EUT (if available) is connected to a power outlet.
- The measurement distance is as appropriate (e.g. 0.5 m).
- The EUT is set into operation.

Premeasurement

- The test antenna is handheld and moved carefully over the EUT to cover the EUT's whole sphere and different polarizations of the antenna.

Final measurement

- The final measurement is performed at the position and antenna orientation causing the highest emissions with Peak and RMS detector (as described in ANSI C 63.4).
- Final levels, frequency, measuring time, bandwidth, correction factor, margin to the limit and limit are recorded. A plot with the graph of the premeasurement and the limit is stored.

9 Measurement uncertainty

Measurement uncertainty	
Test case	**Uncertainty**
Antenna gain	± 3 dB
Spectrum bandwidth	± 21.5 kHz absolute; ± 15.0 kHz relative
Maximum output power	± 1 dB
Detailed conducted spurious emissions @ the band edge	± 1 dB
Band edge compliance radiated	± 3 dB
Spurious emissions conducted	± 3 dB
Spurious emissions radiated below 30 MHz	± 3 dB
Spurious emissions radiated 30 MHz to 1 GHz	± 3 dB
Spurious emissions radiated 1 GHz to 12.75 GHz	± 3.7 dB
Spurious emissions radiated above 12.75 GHz	± 4.5 dB
Spurious emissions conducted below 30 MHz (AC conducted)	± 2.6 dB

10 Summary of measurement results

☒	No deviations from the technical specifications were ascertained
☐	There were deviations from the technical specifications ascertained
☐	This test report is only a partial test report. The content and verdict of the performed test cases are listed below.

TC Identifier	Description	Verdict	Date	Remark
RF-Testing	CFR Part 15 RSS - 247, Issue 1	See table!	2015-12-07	-/-

Test specification clause	Test case	Guideline	Temperature conditions	Power source voltages	Mode	C	NC	NA	NP	Remark
§15.247(b)(4) RSS - 247 / 5.4 (4)	System gain	-/-	Nominal	Nominal	OQPSK	☒	☐	☐	☐	-/-
§15.247(e) RSS - 247 / 5.2 (2)	Power spectral density	KDB 558074 DTS clause: 10.6	Nominal	Nominal	OQPSK	☒	☐	☐	☐	-/-
§15.247(a)(2) RSS - 247 / 5.2 (1)	DTS bandwidth – 6 dB bandwidth	KDB 558074 DTS clause: 8.1	Nominal	Nominal	OQPSK	☒	☐	☐	☐	-/-
RSS Gen clause 4.6.1	Occupied bandwidth	-/-	Nominal	Nominal	OQPSK	☒	☐	☐	☐	-/-
§15.247(b)(3) RSS - 247 / 5.4 (4)	Maximum output power	KDB 558074 DTS clause: 9.1.1	Nominal	Nominal	OQPSK	☒	☐	☐	☐	-/-
§15.247(d) RSS - 247 / 5.5	Detailed spurious emissions @ the band edge - conducted	-/-	Nominal	Nominal	OQPSK	☒	☐	☐	☐	-/-
§15.205 RSS - 247 / 5.5 RSS - Gen	Band edge compliance radiated	KDB 558074 DTS clause: 13.3.2	Nominal	Nominal	OQPSK	☒	☐	☐	☐	-/-
§15.247(d) RSS - 247 / 5.5	TX spurious emissions conducted	KDB 558074 DTS clause: 11.1 & 11.2 11.3	Nominal	Nominal	GFSK	☒	☐	☐	☐	-/-
§15.209(a) RSS - Gen	Spurious emissions radiated below 30 MHz	-/-	Nominal	Nominal	OQPSK	☒	☐	☐	☐	-/-
15.247(d) RSS - 247 / 5.5 §15.109 RSS - Gen	Spurious emissions radiated 30 MHz to 1 GHz	-/-	Nominal	Nominal	OQPSK	☒	☐	☐	☐	-/-
§15.247(d) RSS - 247 / 5.5 §15.109 RSS - Gen	Spurious emissions radiated above 1 GHz	-/-	Nominal	Nominal	OQPSK	☒	☐	☐	☐	-/-
§15.107(a) §15.207	Conducted emissions below 30 MHz (AC conducted)	-/-	Nominal	Nominal	OQPSK	☒	☐	☐	☐	-/-

Note: C = Compliant; NC = Not compliant; NA = Not applicable; NP = Not performed

11 Additional comments

Reference documents: None

Special test descriptions: None

Configuration descriptions: None

Test mode: ☐ No testmode available

☒ Special software is used.
EUT is transmitting pseudo random data by itself

12 Measurement results

12.1 System gain

Measurement:

The antenna gain of the complete system is calculated by the difference of radiated power in EIRP and the conducted power of the module.

Measurement parameters	
Detector	Peak
Sweep time	Auto
Resolution bandwidth	3 MHz
Video bandwidth	3 MHz
Span	5 MHz
Trace mode	Max hold
Test setup	See sub clause 7.2 A See sub clause 7.5 A
Measurement uncertainty	See sub clause 9

Limits:

FCC	IC
Antenna gain	
6 dBi	

Results:

T_{nom}	V_{nom}	2402 MHz	2440 MHz	2480 MHz
Conducted power [dBm] Measured with OQPSK modulation		-0.7	-0.2	0.3
Radiated power [dBm] Measured with OQPSK modulation		3.7	2.7	3.8
Gain [dBi] Calculated		4.4	2.9	3.5

12.2 Power spectral density

Description:

Measurement of the power spectral density of a digital modulated system.

Measurement parameters	
Detector	Peak
Sweep time	Auto
Resolution bandwidth	3 kHz
Video bandwidth	10 kHz
Span	≥ EBW
Trace mode	Max hold
Test setup	See sub clause 7.5 A
Measurement uncertainty	See sub clause 9

Limits:

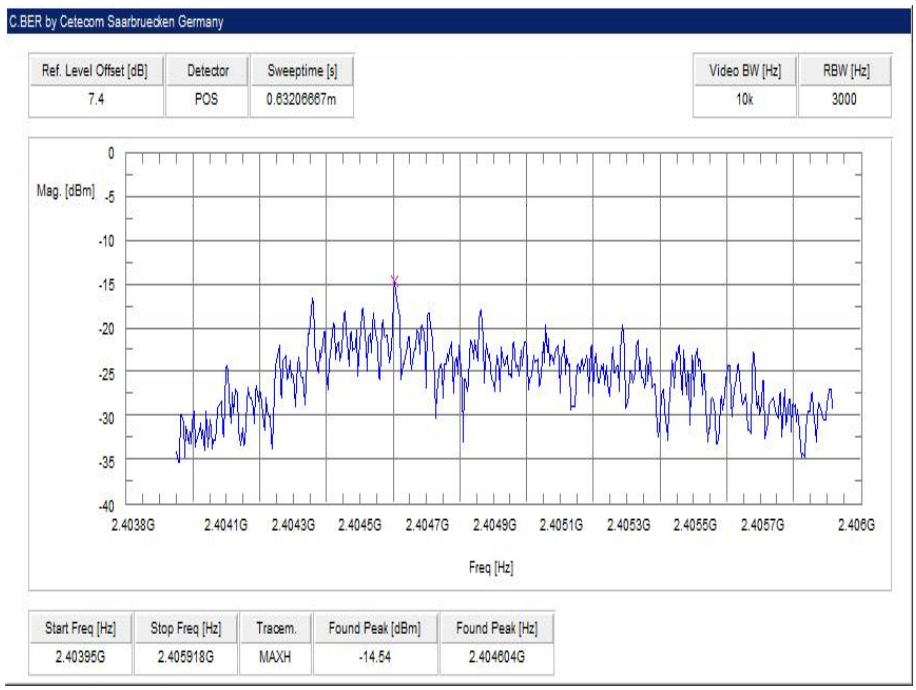
FCC	IC
Power spectral density	
For digitally modulated systems the transmitter power spectral density conducted from the transmitter to the antenna shall not be greater than 8 dBm in any 3 kHz band during any time interval of continuous transmission or over 1.0 second if the transmission exceeds 1.0-second duration.	

Results:

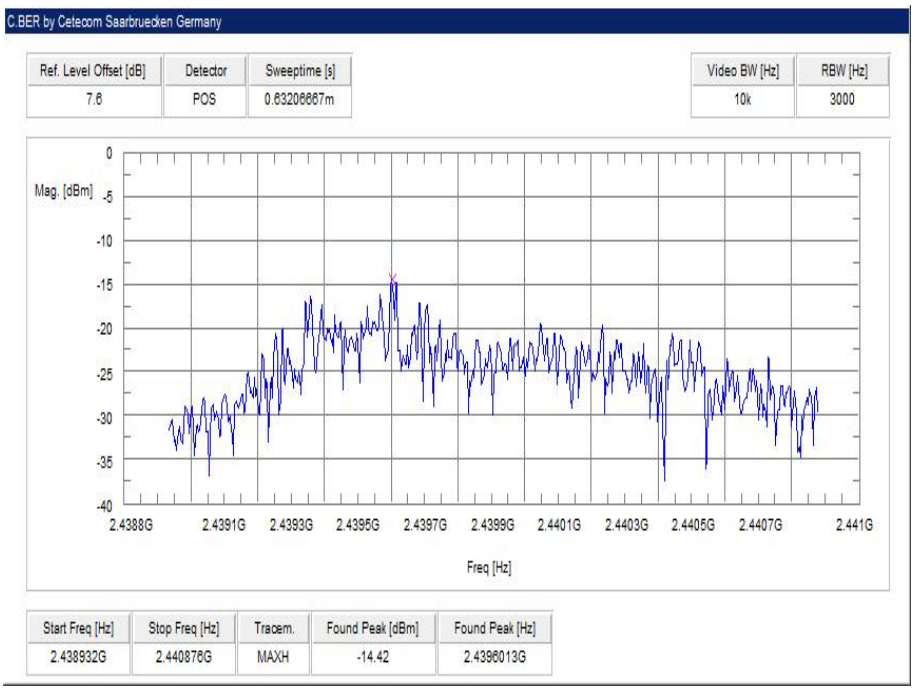
	Frequency		
	2405 MHz	2440 MHz	2480 MHz
Power spectral density [dBm / 3kHz]	-14.5	-14.4	-14.5

Plots:

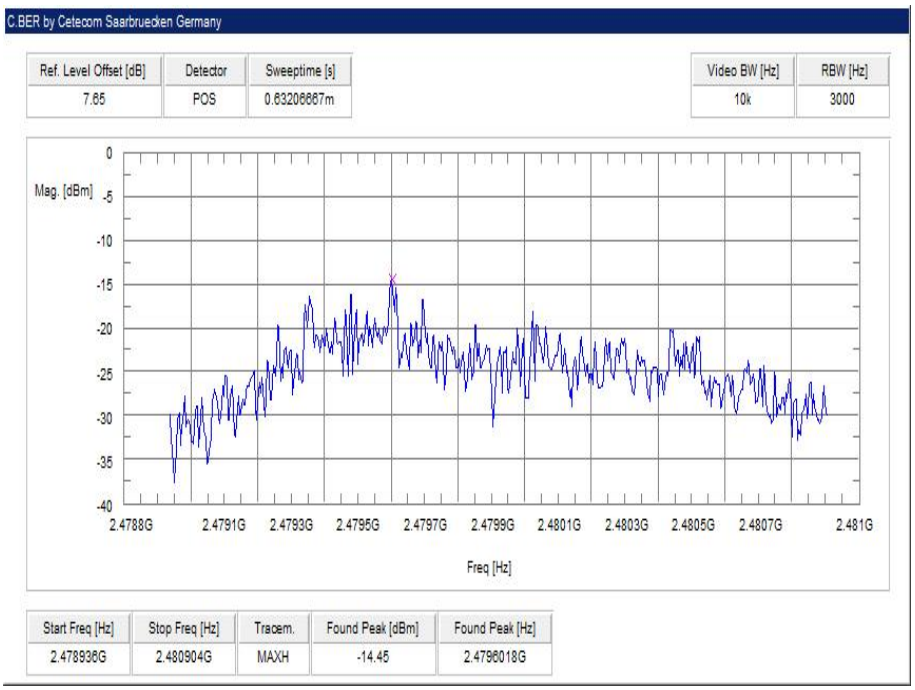
Plot 1: lowest channel



Plot 2: mid channel



Plot 3: highest channel



12.3 DTS bandwidth – 6 dB bandwidth

Description:

Measurement of the 6 dB bandwidth of the modulated signal.

Measurement parameters	
According to DTS clause: 8.1	
Detector	Peak
Sweep time	Auto
Resolution bandwidth	100 kHz
Video bandwidth	300 kHz
Span	5 MHz
Measurement procedure	Using 3 marker (max + 2x-6dB)
Trace mode	Max hold (allow trace to stabilize)
Test setup	See sub clause 7.5 A
Measurement uncertainty	See sub clause 9

Limits:

FCC	IC
DTS bandwidth – 6 dB bandwidth	
Systems using digital modulation techniques may operate in the 2400–2483.5 MHz band. The minimum 6 dB bandwidth shall be at least 500 kHz.	

Results:

	Frequency		
	2405 MHz	2440 MHz	2480 MHz
6 dB bandwidth [MHz]	1.3	1.3	1.3

Plots:

Plot 1: lowest channel

Plot 2: mid channel

Plot 3: highest channel

12.4 Occupied bandwidth – 99% emission bandwidth

Description:

Measurement of the 99% bandwidth of the modulated signal acc. RSS-GEN.

Measurement parameters	
Detector	Peak
Sweep time	Auto
Resolution bandwidth	30 kHz
Video bandwidth	100 kHz
Span	5 MHz
Measurement procedure	Measurement of the 99% bandwidth using the integration function of the analyzer
Trace mode	Max hold (allow trace to stabilize)
Test setup	See sub clause 7.5 A
Measurement uncertainty	See sub clause 9

Usage:

-/-	IC
Occupied bandwidth – 99% emission bandwidth	
OBW is necessary for emission designator	

Results:

	Frequency		
	2405 MHz	2440 MHz	2480 MHz
99% bandwidth [MHz]	2.3	2.4	2.4

Plots:

Plot 1: lowest channel

Plot 2: mid channel

Plot 3: highest channel

12.5 Maximum output power

Description:

Measurement of the maximum output power conducted and radiated. EUT in single channel mode.

Measurement parameters	
Detector	Peak
Sweep time	Auto
Resolution bandwidth	3 MHz
Video bandwidth	10 MHz
Span	10 MHz
Trace mode	Max hold
Test setup	See sub clause 7.5 A
Measurement uncertainty	See sub clause 9

Limits:

FCC	IC
Maximum output power	
[Conducted: 0.125 W – antenna gain max. 6 dBi] Systems using more than 75 hopping channels: Conducted: 1.0 W – antenna gain max. 6 dBi	

Results:

	Frequency		
	2405 MHz	2440 MHz	2480 MHz
Maximum output power conducted [dBm]	-0.7	-0.0	0.1

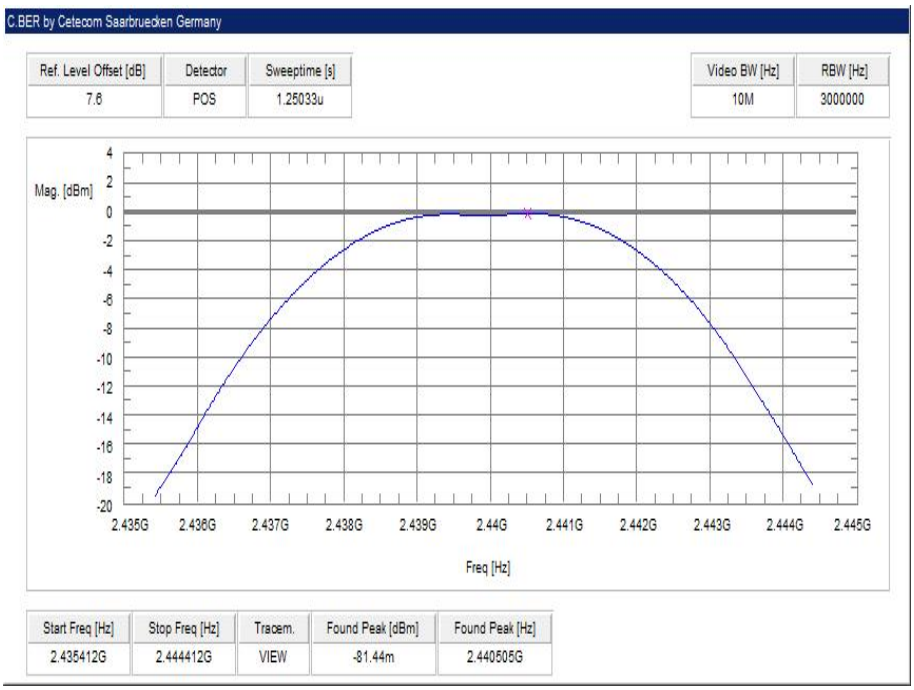
	Frequency		
	2405 MHz	2440 MHz	2480 MHz
Maximum output power radiated - EIRP [dBm]*	3.7	2.9	3.6

*) - Values calculated with antenna gain

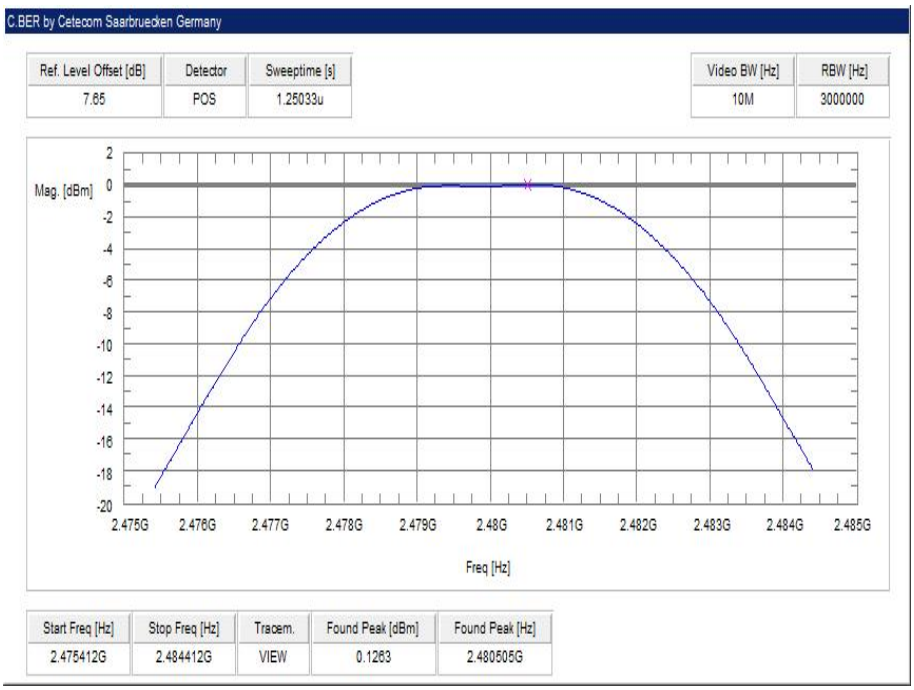
Plots:

Plot 1: lowest channel

Plot 2: mid channel



Plot 3: highest channel



12.6 Detailed spurious emissions @ the band edge - conducted

Description:

Measurement of the conducted band edge compliance. EUT is measured at the lower and upper band edge in single channel.

Measurement parameters	
Detector	Peak
Sweep time	Auto
Resolution bandwidth	100 kHz
Video bandwidth	300 kHz / 500 kHz
Span	Lower Band Edge: 2395 – 2405 MHz higher Band Edge: 2478 – 2489 MHz
Trace mode	Max hold
Test setup	See sub clause 7.5 A
Measurement uncertainty	See sub clause 9

Limits:

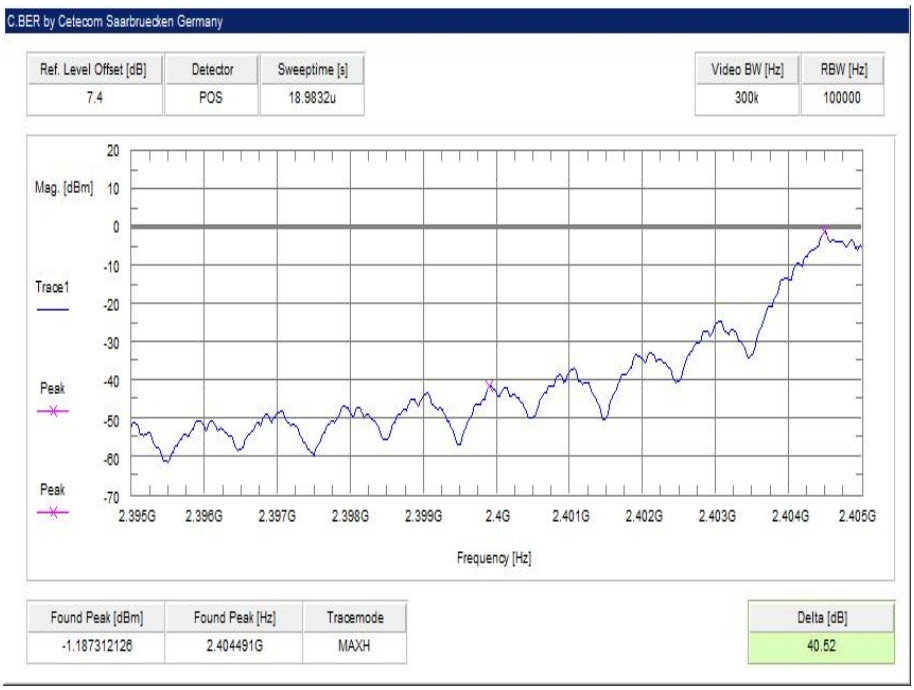
FCC	IC
In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement. Attenuation below the general limits specified in Section 15.209(a) is not required.	

Result:

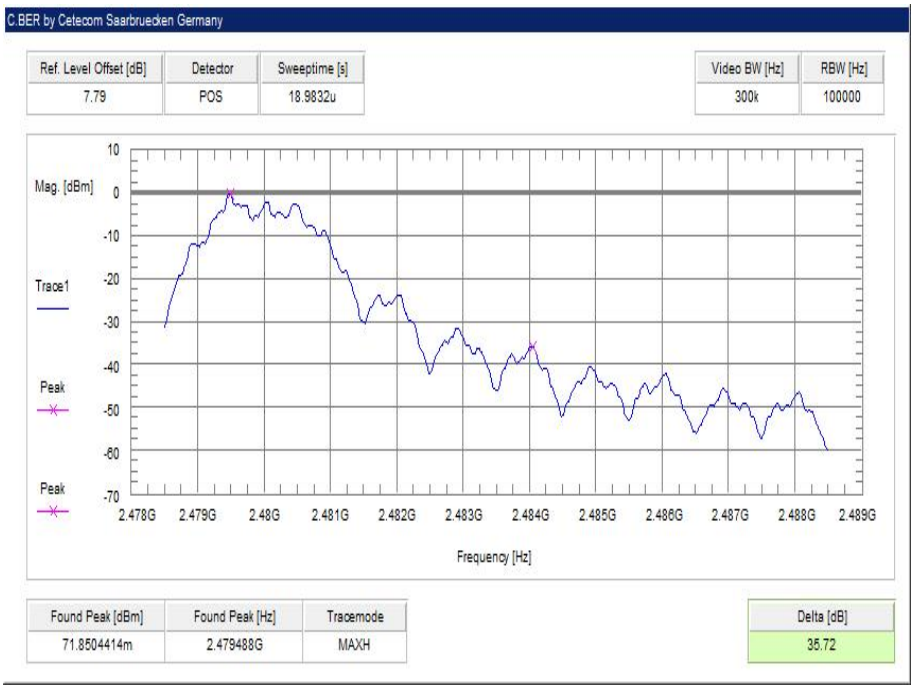
Scenario	Spurious band edge conducted [dB]
Modulation	OQPSK
Lower band edge – hopping off	> 20 dB
Upper band edge – hopping off	> 20 dB

Plots:

Plot 1: Lower band edge



Plot 2: Upper band edge



12.7 Band edge compliance radiated

Description:

Measurement of the radiated band edge compliance. The EUT is turned in the position that results in the maximum level at the band edge. Then a sweep over the corresponding restricted band is performed. The EUT is set to single channel mode and the transmit channel is channel 00 for the lower restricted band and channel 39 for the upper restricted band. Measurement distance is 3m.

Measurement parameters	
Detector	Peak / RMS
Sweep time	Auto
Resolution bandwidth	1 MHz
Video bandwidth	3 MHz
Span	Lower Band: 2300 – 2400 MHz higher Band: 2480 – 2500 MHz
Trace mode	Max hold
Test setup	See sub clause 7.2 A
Measurement uncertainty	See sub clause 9

Limits:

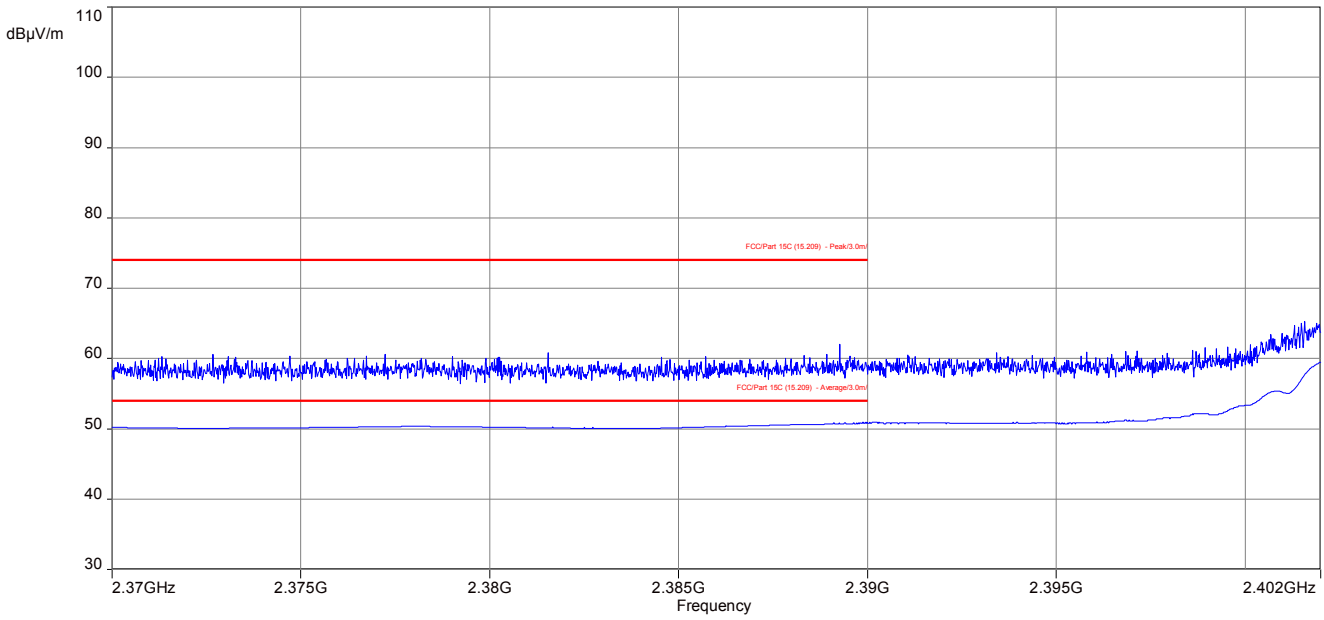
FCC	IC
Band edge compliance radiated	
In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement. Attenuation below the general limits specified in Section 15.209(a) is not required. In addition, radiated emissions which fall in the restricted bands, as defined in Section 15.205(a), must also comply with the radiated emission limits specified in Section 15.209(a) (see Section 5.205(c)).	
54 dBµV/m AVG 74 dBµV/m Peak	

Result:

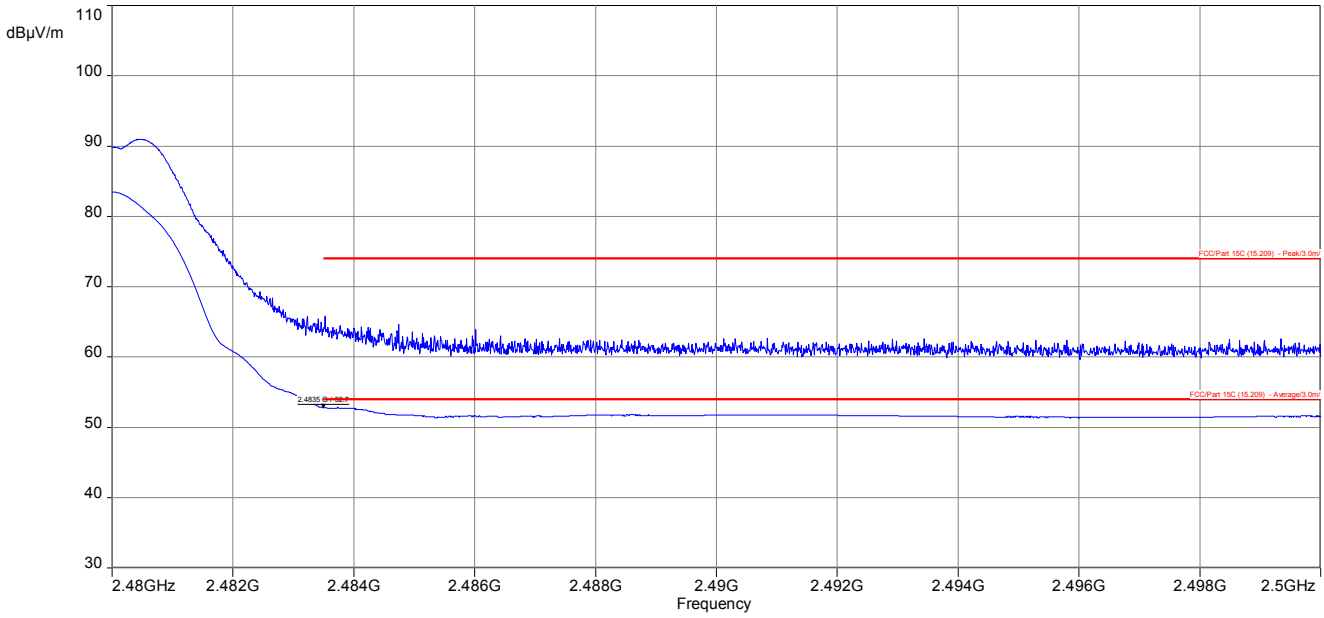
Scenario	Band edge compliance radiated [dBµV/m]
Modulation	OQPSK
Lower restricted band	< 54 AVG / < 74 PP
Upper restricted band	< 54 AVG / < 74 PP

Plots:

Plot 1: Lower restricted band



Plot 2: Upper restricted band



12.8 TX spurious emissions conducted

Description:

Measurement of the conducted spurious emissions in transmit mode. The EUT is set to single channel mode and the transmit channel is channel 11, channel 18 and channel 26.

Measurement parameters	
Detector	Peak
Sweep time	Auto
Resolution bandwidth	100 kHz
Video bandwidth	300 kHz or 500 kHz
Span	9 kHz to 25 GHz
Trace mode	Max hold
Test setup	See sub clause 7.5 A
Measurement uncertainty	See sub clause 9

Limits:

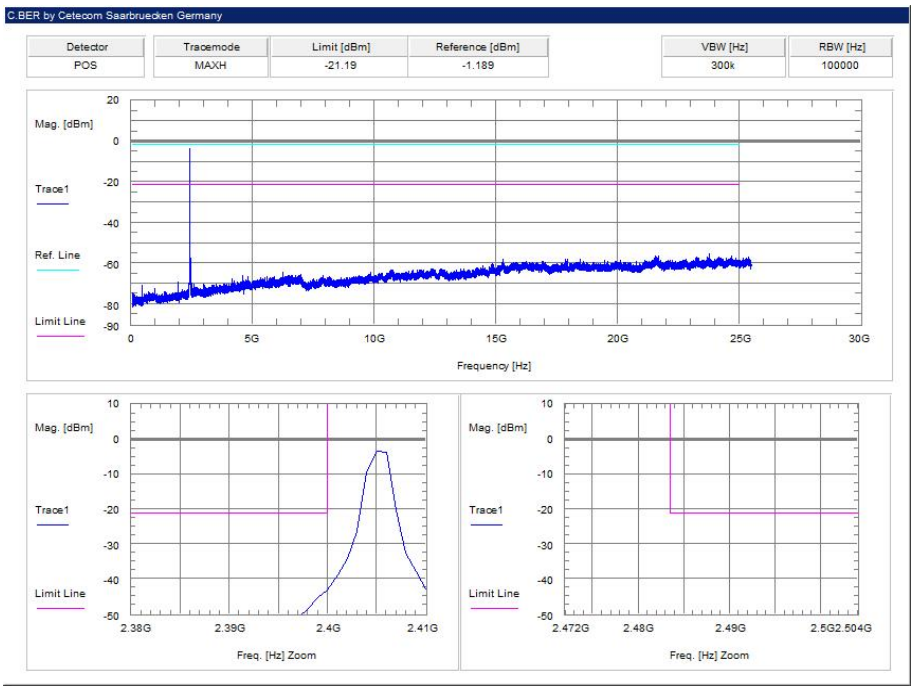
FCC	IC
TX spurious emissions conducted	
In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement. Attenuation below the general limits specified in Section 15.209(a) is not required	

Results:

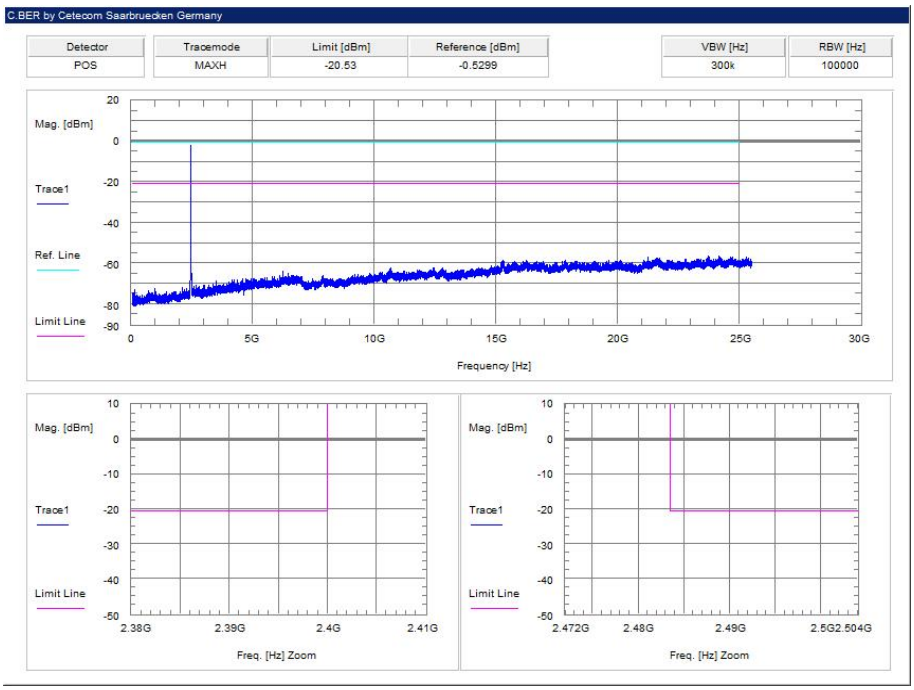
TX spurious emissions conducted					
f [MHz]		amplitude of emission [dBm]	limit max. allowed emission power	actual attenuation below frequency of operation [dB]	results
2405		-1.2	30 dBm		Operating frequency
All detected emissions are more than 6 dB below the limit!			-20 dBc		compliant
2440		-0.5	30 dBm		Operating frequency
All detected emissions are more than 6 dB below the limit!			-20 dBc		compliant
2480		0.0	30 dBm		Operating frequency
All detected emissions are more than 6 dB below the limit!			-20 dBc		compliant

Plots:

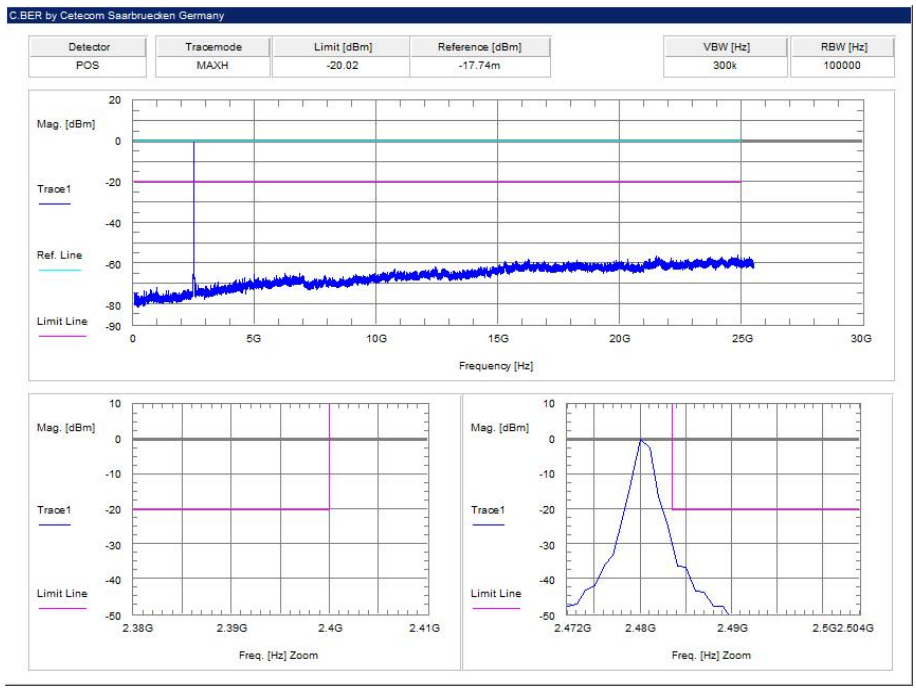
Plot 1: lowest channel



Plot 2: mid channel



Plot 3: highest channel



12.9 Spurious emissions radiated below 30 MHz

Description:

Measurement of the radiated spurious emissions in transmit mode below 30 MHz. The EUT is set to single channel mode and the transmit channel is channel 19. This measurement is representative for all channels and modes. If critical peaks are found channel 11, 18 and channel 26 will be measured too. The measurement is performed in the mode with the highest output power. The limits are recalculated to a measurement distance of 3 m according the ANSI C63.10.

Measurement parameters	
Detector	Peak / Quasi peak
Sweep time	Auto
Resolution bandwidth	F < 150 kHz: 1 kHz F > 150 kHz: 100 kHz
Video bandwidth	F < 150 kHz: 200 Hz F > 150 kHz: 9 kHz
Span	9 kHz to 30 MHz
Trace mode	Max hold
Test setup	See sub clause 7.2 C
Measurement uncertainty	See sub clause 9

Limits:

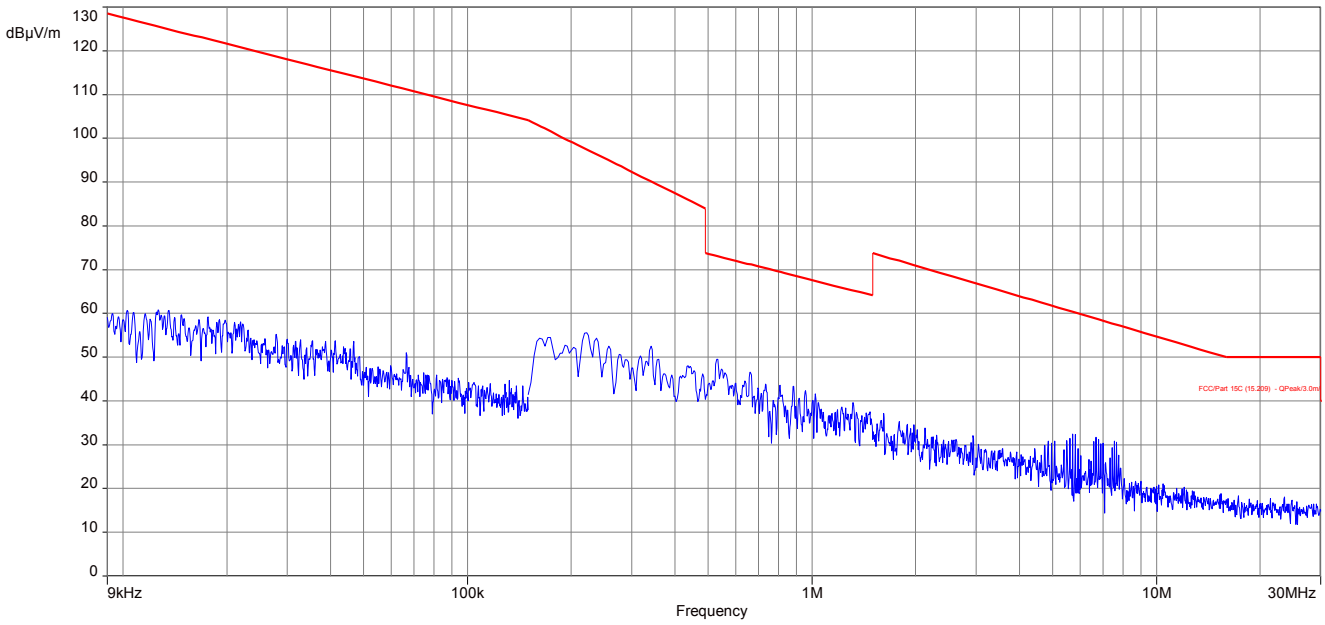
FCC		IC
TX spurious emissions radiated below 30 MHz		
Frequency (MHz)	Field strength (dBµV/m)	Measurement distance
0.009 – 0.490	2400/F(kHz)	300
0.490 – 1.705	24000/F(kHz)	30
1.705 – 30.0	30	30

Results:

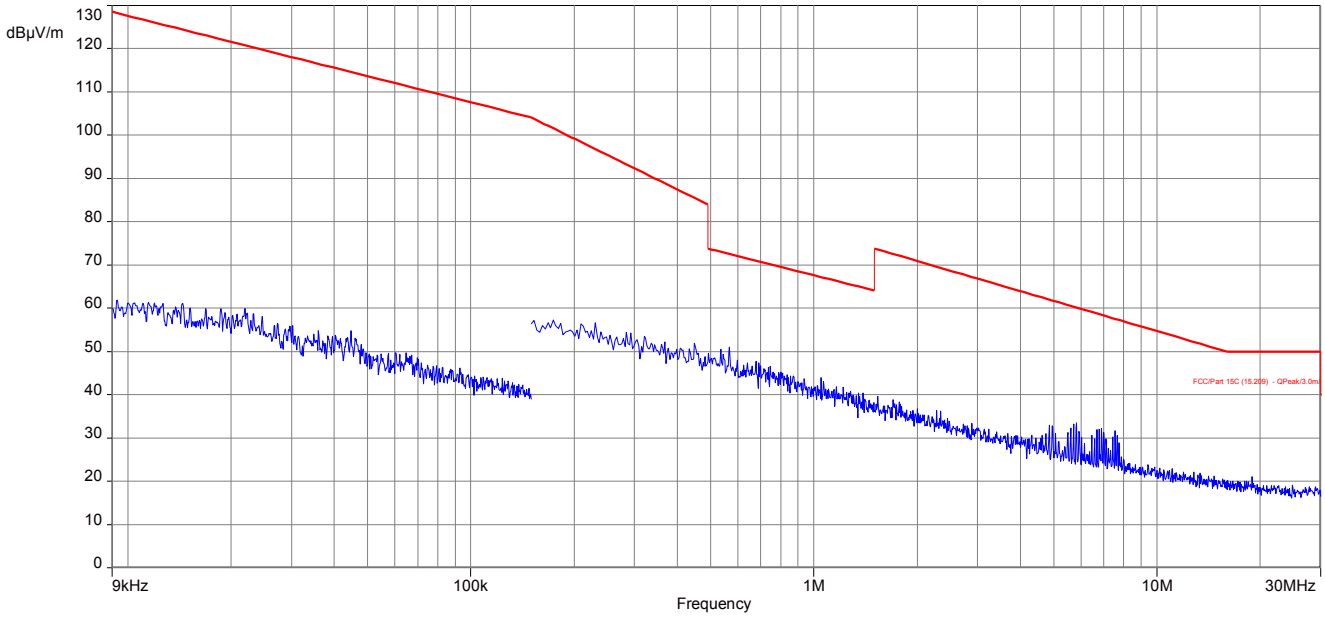
TX spurious emissions radiated below 30 MHz [dBµV/m]		
F [MHz]	Detector	Level [dBµV/m]
All detected emissions are more than 20 dB below the limit.		

Plots:

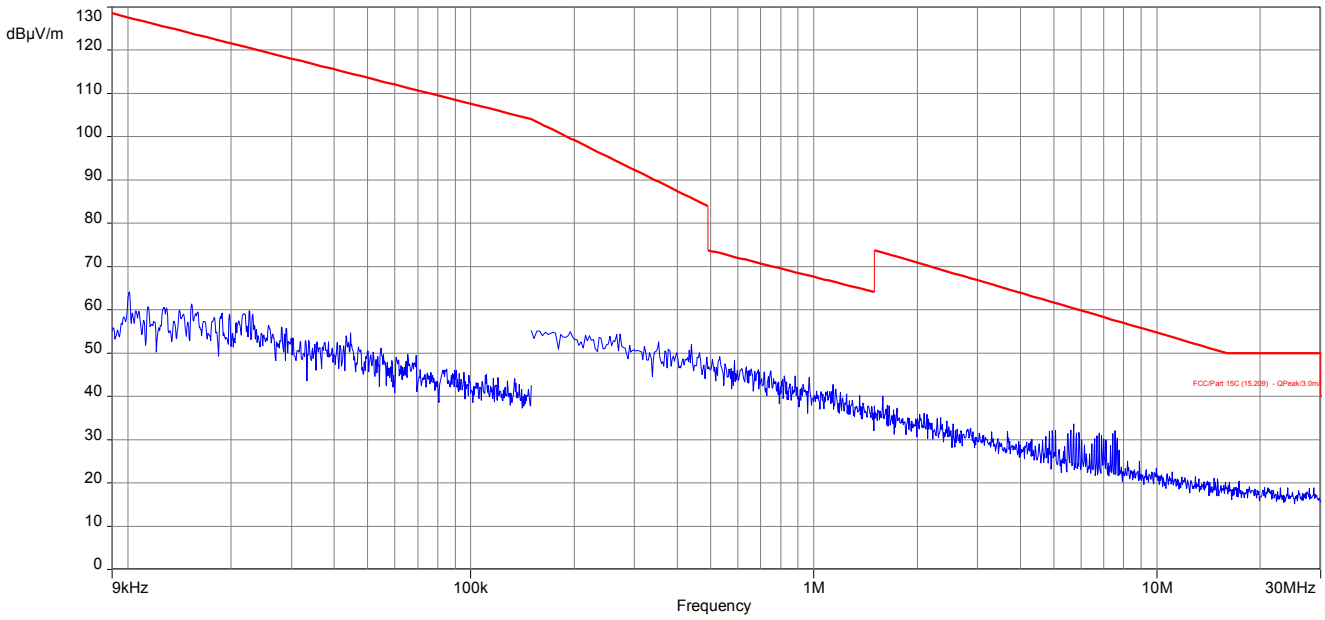
Plot 1: 9 kHz to 30 MHz, channel 11, transmit mode



Plot 2: 9 kHz to 30 MHz, channel 18, transmit mode



Plot 3: 9 kHz to 30 MHz, channel 26, transmit mode



12.10 Spurious emissions radiated 30 MHz to 1 GHz

Description:

Measurement of the radiated spurious emissions in transmit mode. The EUT is set to single channel mode and the transmit channel is channel 11, channel 18 and channel 26. The measurement is performed in the mode with the highest output power.

Measurement parameters	
Detector	Peak / Quasi Peak
Sweep time	Auto
Resolution bandwidth	3 x VBW
Video bandwidth	120 kHz
Span	30 MHz to 1 GHz
Trace mode	Max hold
Measured modulation	OQPSK
Test setup	See sub clause 7.1 A
Measurement uncertainty	See sub clause 9

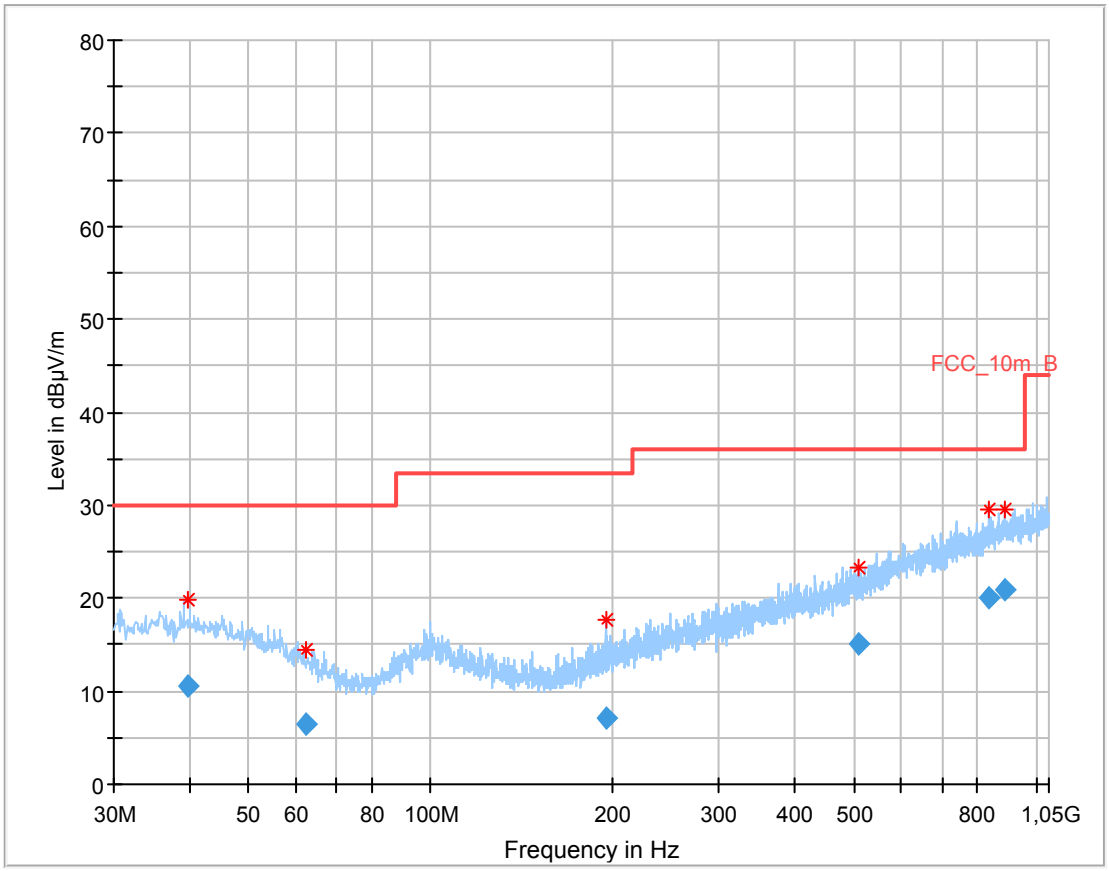
The modulation with the highest output power was used to perform the transmitter spurious emissions. If spurious were detected a re-measurement was performed on the detected frequency with each modulation.

Limits:

FCC		IC
TX spurious emissions radiated		
In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement. Attenuation below the general limits specified in Section 15.209(a) is not required. In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in §15.209(a) (see §15.205(c)).		
§15.209		
Frequency (MHz)	Field strength (dBµV/m)	Measurement distance
30 - 88	30.0	10
88 – 216	33.5	10
216 – 960	36.0	10
Above 960	54.0	3

Plots: Transmit mode

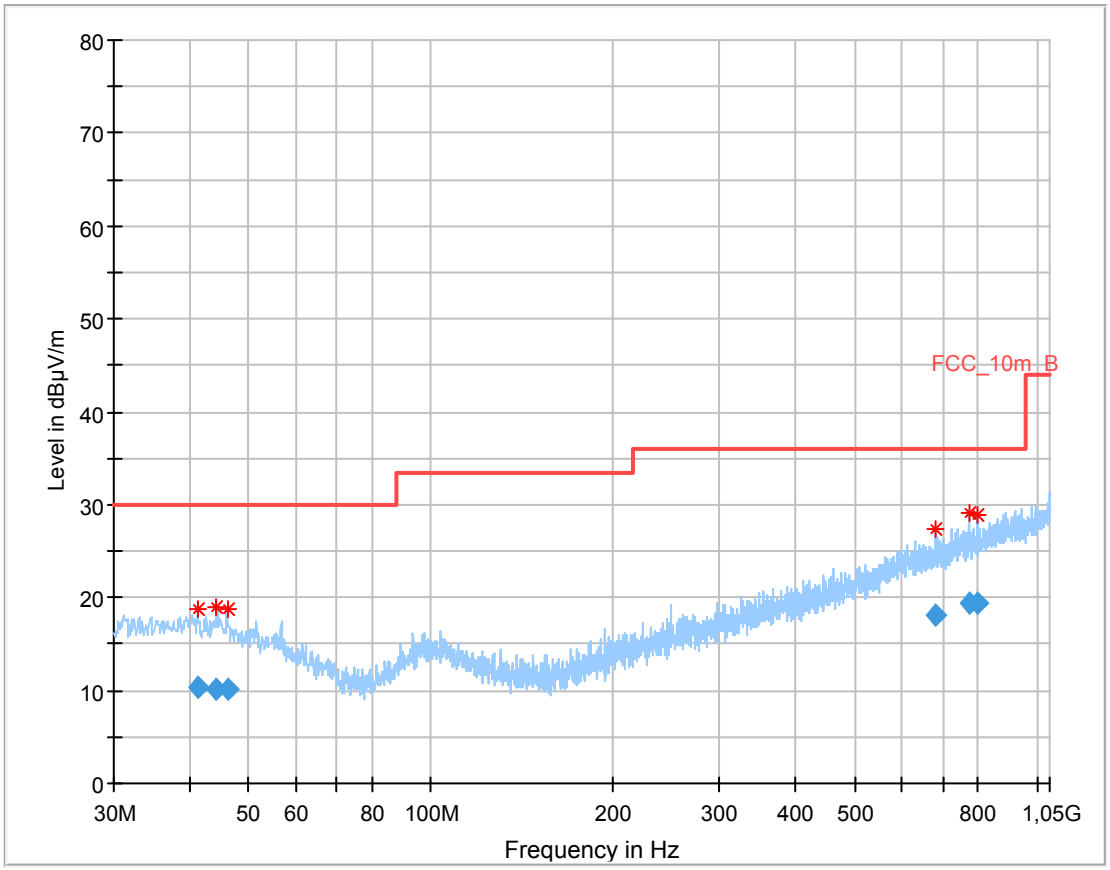
Plot 1: 30 MHz to 1 GHz, TX mode, channel 11, vertical & horizontal polarization



Final_Result

Frequency (MHz)	QuasiPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
39.777750	10.64	30.00	19.36	1000.0	120.000	170.0	H	80	14.0
62.094000	6.51	30.00	23.49	1000.0	120.000	101.0	H	261	10.1
194.947800	7.10	33.50	26.40	1000.0	120.000	170.0	V	280	11.4
510.795450	15.20	36.00	20.80	1000.0	120.000	170.0	H	190	18.8
836.089200	20.15	36.00	15.85	1000.0	120.000	170.0	H	80	23.3
889.505400	20.97	36.00	15.03	1000.0	120.000	101.0	H	190	24.0

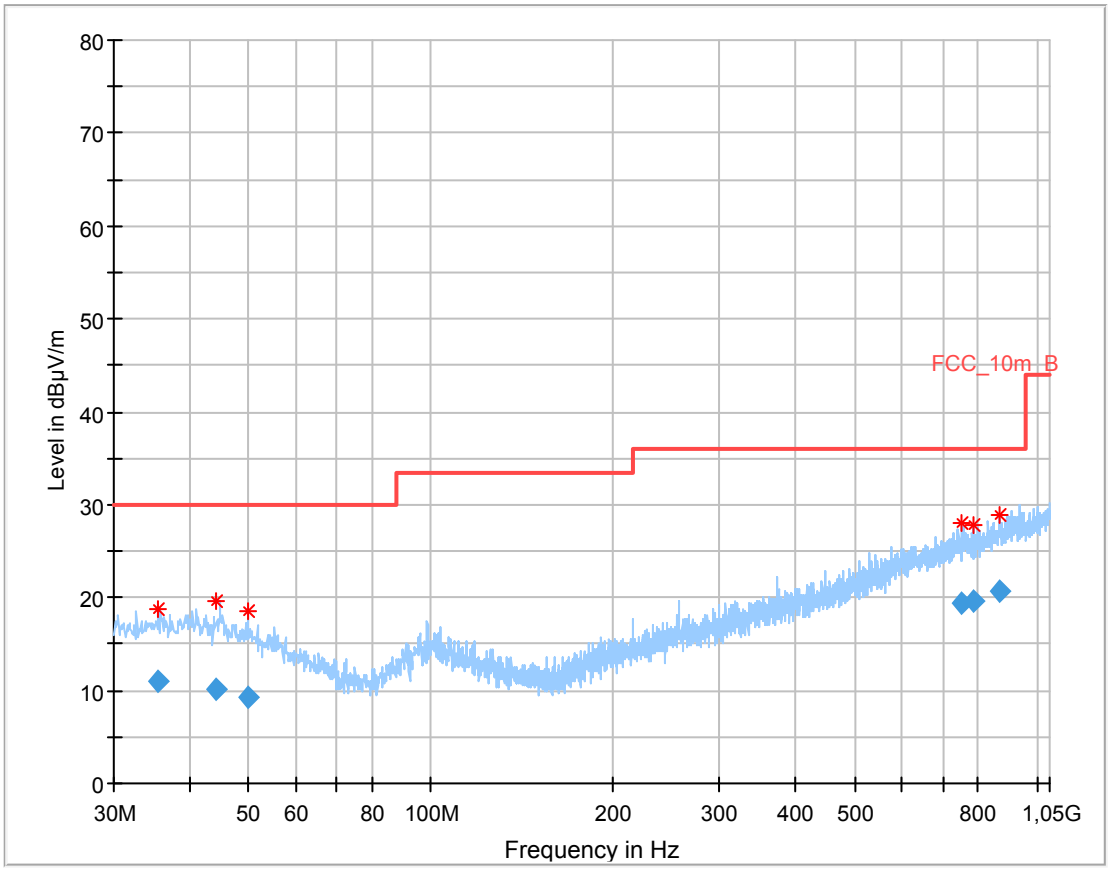
Plot 2: 30 MHz to 1 GHz, TX mode, channel 18, vertical & horizontal polarization



Final_Result

Frequency (MHz)	QuasiPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
41.444850	10.30	30.00	19.70	1000.0	120.000	170.0	H	261	14.0
44.316450	10.15	30.00	19.85	1000.0	120.000	170.0	V	81	13.9
46.221000	10.12	30.00	19.88	1000.0	120.000	170.0	V	10	13.5
679.281000	18.15	36.00	17.85	1000.0	120.000	101.0	H	170	21.4
771.856950	19.40	36.00	16.60	1000.0	120.000	170.0	V	10	22.7
797.373900	19.50	36.00	16.50	1000.0	120.000	170.0	H	280	22.7

Plot 3: 30 MHz to 1 GHz, TX mode, channel 26, vertical & horizontal polarization

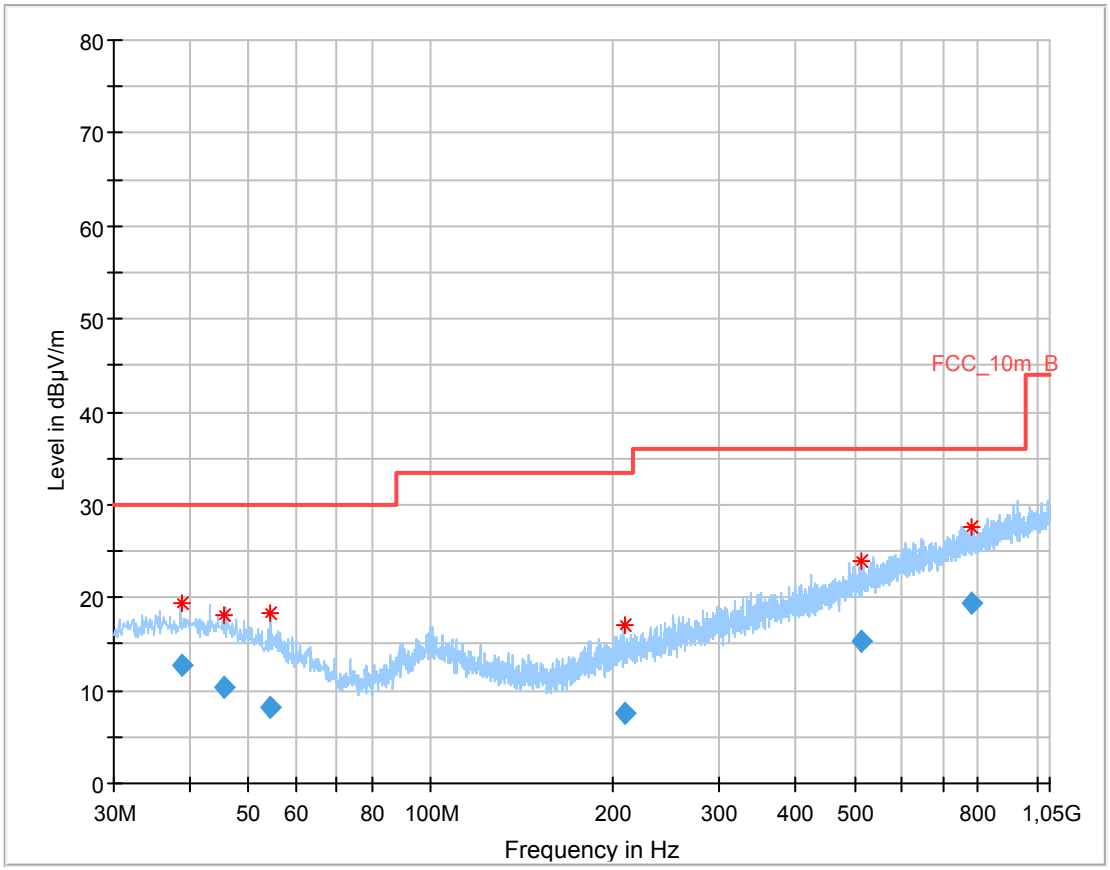


Final_Result

Frequency (MHz)	QuasiPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
35.404050	10.97	30.00	19.03	1000.0	120.000	101.0	V	10	13.8
44.351100	10.09	30.00	19.91	1000.0	120.000	98.0	H	280	13.9
49.807200	9.31	30.00	20.69	1000.0	120.000	170.0	V	-10	12.7
753.744750	19.44	36.00	16.56	1000.0	120.000	170.0	V	100	22.7
784.715850	19.53	36.00	16.47	1000.0	120.000	170.0	V	81	22.7
867.153750	20.72	36.00	15.28	1000.0	120.000	100.0	H	100	23.7

Plots: Receiver mode

Plot 1: 30 MHz to 1 GHz, RX / idle – mode, vertical & horizontal polarization



Final_Result

Frequency (MHz)	QuasiPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
38.745450	12.74	30.00	17.26	1000.0	120.000	98.0	V	260	14.0
45.477450	10.44	30.00	19.56	1000.0	120.000	100.0	H	-10	13.7
54.197550	8.17	30.00	21.83	1000.0	120.000	101.0	V	-10	12.0
208.263300	7.60	33.50	25.90	1000.0	120.000	170.0	V	280	12.0
513.492000	15.28	36.00	20.72	1000.0	120.000	170.0	H	280	18.9
778.607400	19.46	36.00	16.54	1000.0	120.000	102.0	V	171	22.7

12.11 Spurious emissions radiated above 1 GHz

Description:

Measurement of the radiated spurious emissions in transmit mode. The EUT is set to single channel mode and the transmit channel is channel 11, channel 18 and channel 26. The measurement is performed in the mode with the highest output power.

Measurement parameters	
Detector	Peak / RMS
Sweep time	Auto
Resolution bandwidth	1 MHz
Video bandwidth	3 x RBW
Span	1 GHz to 26 GHz
Trace mode	Max hold
Measured modulation	OQPSK
Test setup	See sub clause 7.2 A (1 GHz - 12.75 GHz) See sub clause 7.3 A (12.75 GHz - 26 GHz)
Measurement uncertainty	See sub clause 9

The modulation with the highest output power was used to perform the transmitter spurious emissions. If spurious were detected a re-measurement was performed on the detected frequency with each modulation.

Limits:

FCC		IC
TX spurious emissions radiated		
In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement. Attenuation below the general limits specified in Section 15.209(a) is not required. In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in §15.209(a) (see §15.205(c)).		
§15.209		
Frequency (MHz)	Field strength (dBµV/m)	Measurement distance
Above 960	54.0	3

Results: Transmitter mode

TX spurious emissions radiated [dBµV/m]								
Channel 11			Channel 18			Channel 26		
F [MHz]	Detector	Level [dBµV/m]	F [MHz]	Detector	Level [dBµV/m]	F [MHz]	Detector	Level [dBµV/m]
4808	Peak	54.2	-/-	Peak	-/-	-/-	Peak	-/-
	AVG	50.2		AVG	-/-		AVG	-/-
-/-	Peak	-/-	-/-	Peak	-/-	-/-	Peak	-/-
	AVG	-/-		AVG	-/-		AVG	-/-
-/-	Peak	-/-	-/-	Peak	-/-	-/-	Peak	-/-
	AVG	-/-		AVG	-/-		AVG	-/-

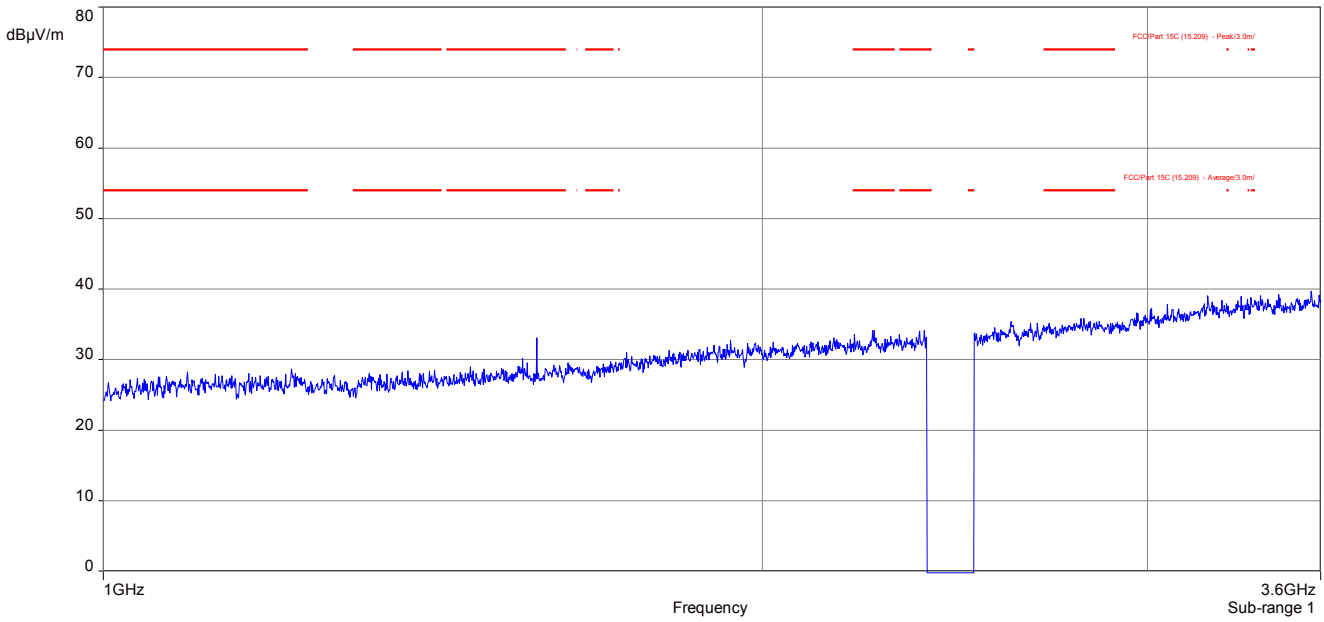
Results: Receiver mode

RX spurious emissions radiated [dBµV/m]		
F [MHz]	Detector	Level [dBµV/m]
All detected emissions are more than 20 dB below the limit.		
-/-	Peak	-/-
	AVG	-/-

Note: The limit was recalculated with 20 dB / decade (Part 15.31) for all radiated spurious emissions 30 MHz to 1 GHz from 3 meter limit to a 10 meter distance. (40dB/decade for emissions < 30MHz)

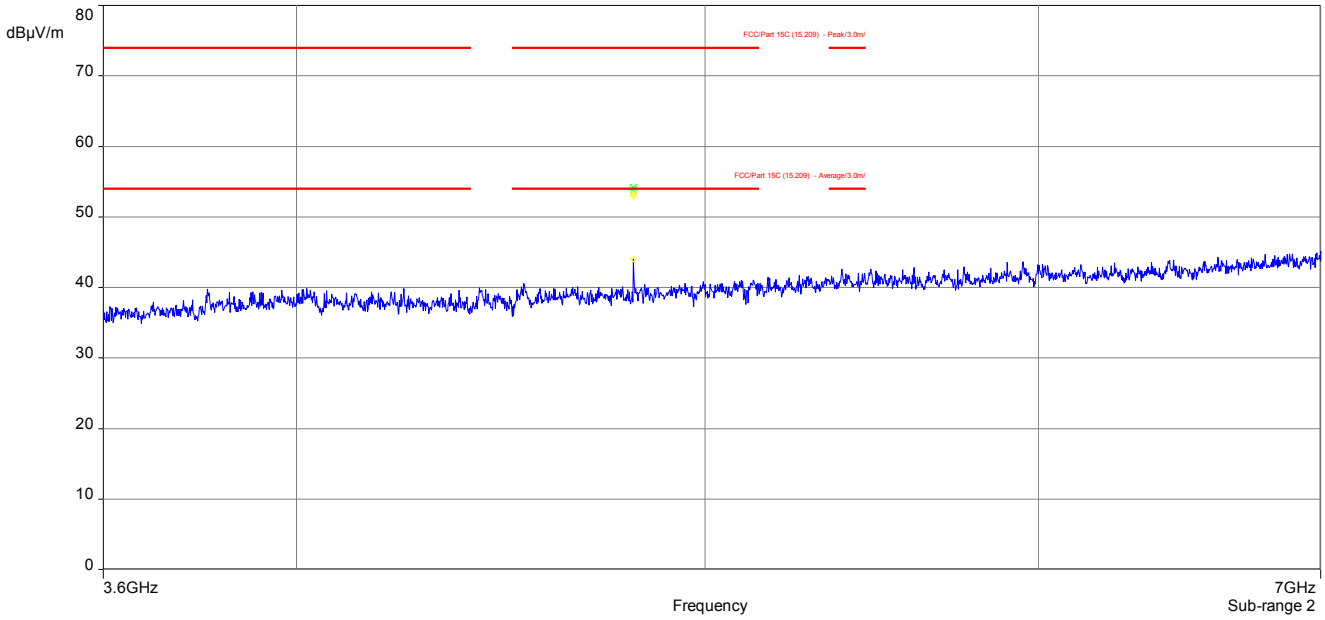
Plots: Transmitter mode

Plot 1: 1 GHz to 3.6 GHz, TX mode, channel 11, vertical & horizontal polarization

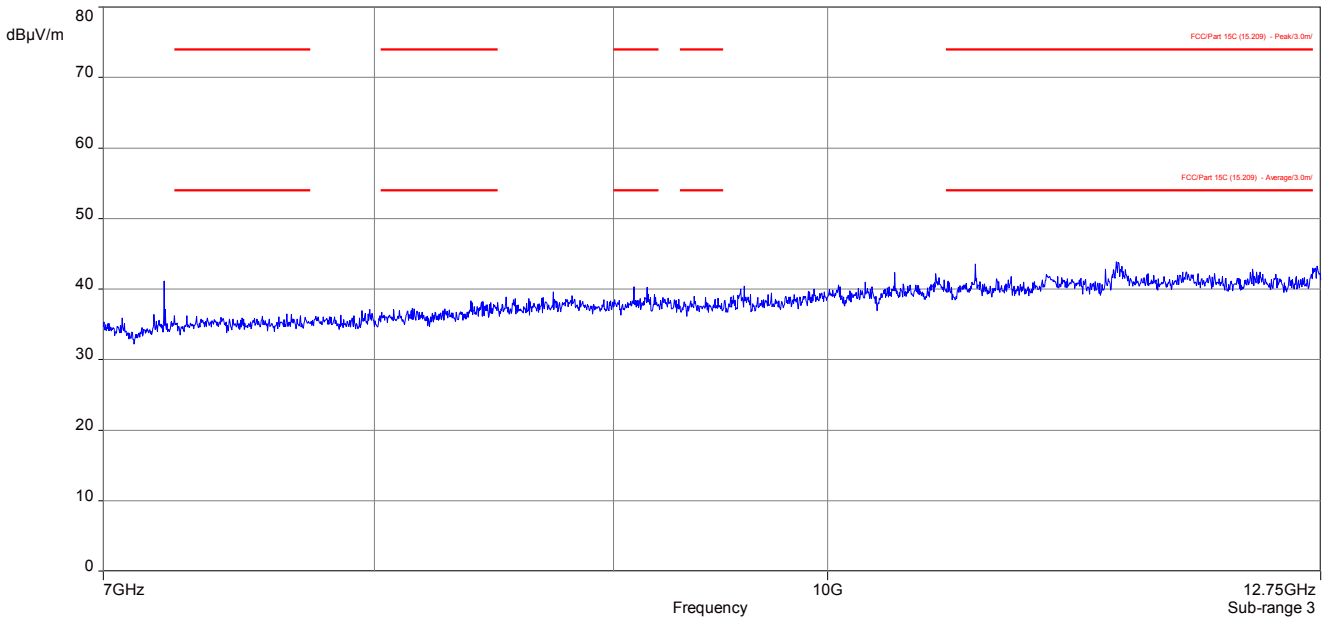


The carrier signal is notched with a 2.4 GHz band rejection filter.

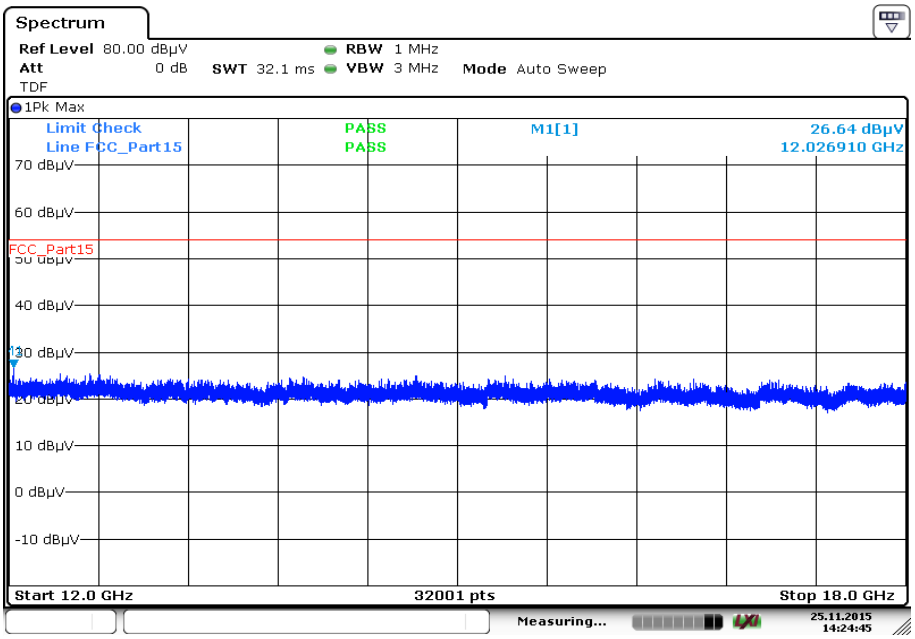
Plot 2: 3.6 GHz to 7 GHz, TX mode, channel 11, vertical & horizontal polarization



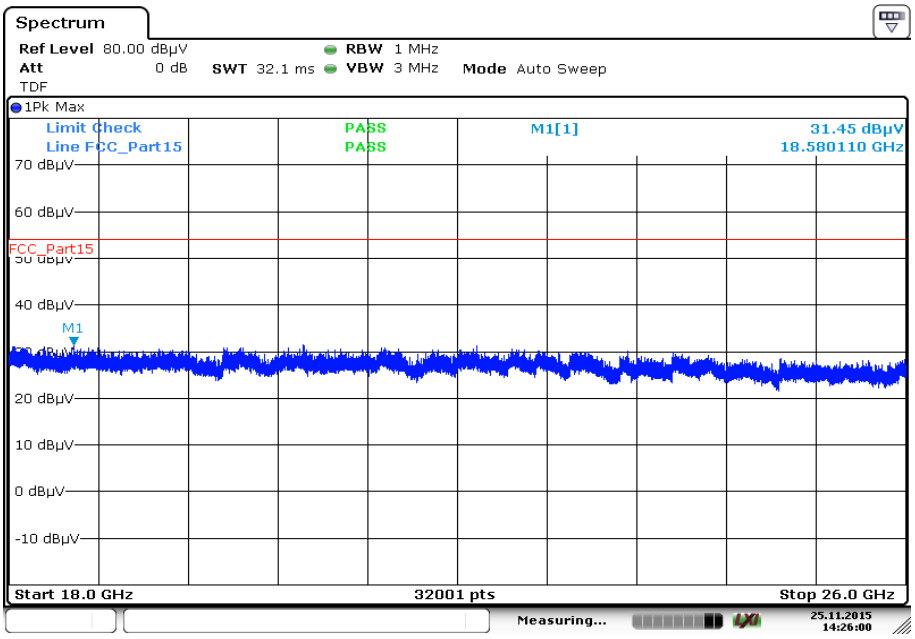
Plot 3: 7 GHz to 12.75 GHz, TX mode, channel 11, vertical & horizontal polarization



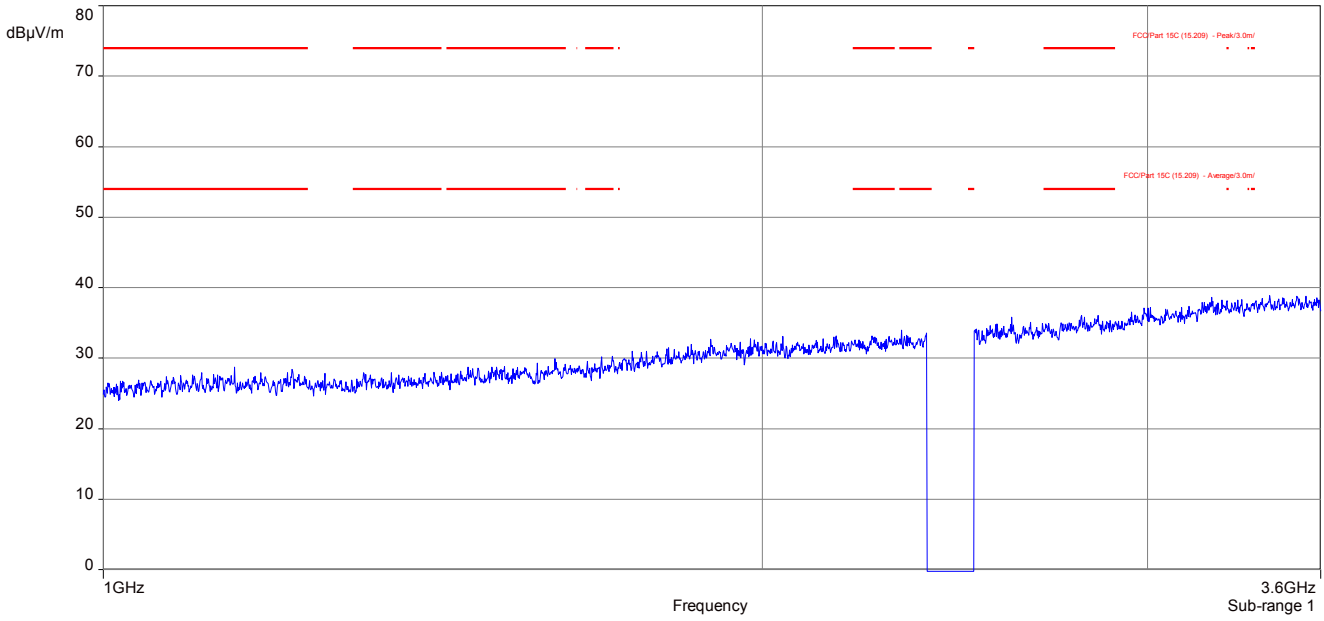
Plot 4: 12.75 GHz to 18 GHz, TX mode, channel 11, vertical & horizontal polarization



Plot 5: 18 GHz to 26 GHz, TX mode, channel 11, vertical & horizontal polarization

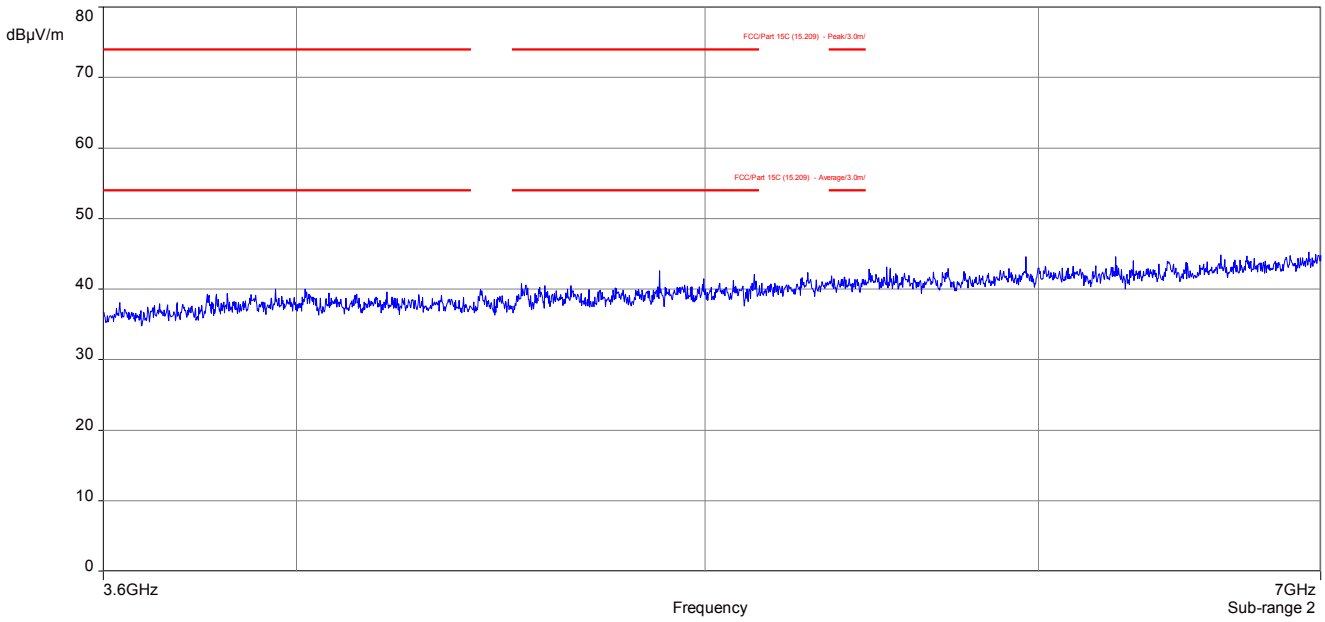


Plot 6: 1 GHz to 3.6 GHz, TX mode, channel 18, vertical & horizontal polarization

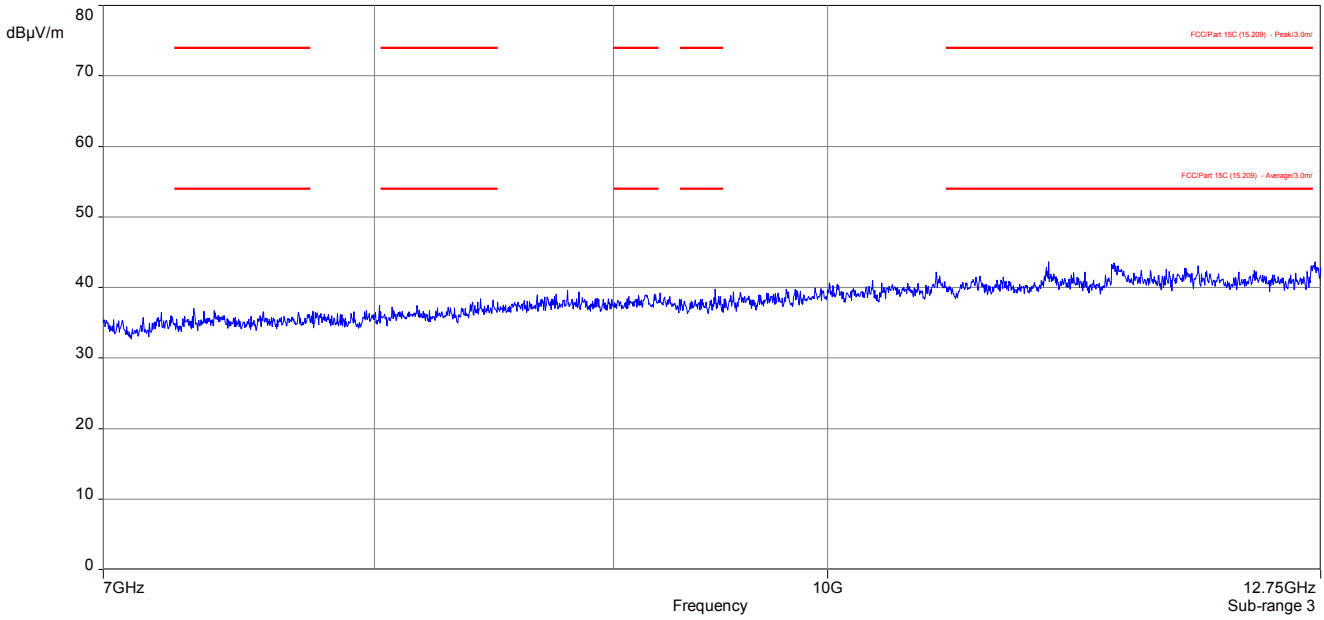


The carrier signal is notched with a 2.4 GHz band rejection filter.

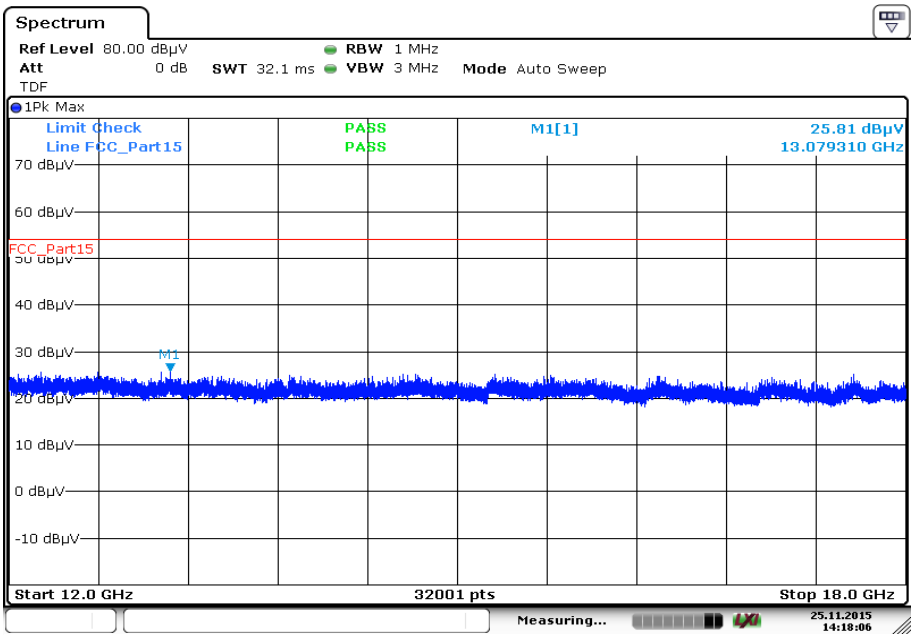
Plot 7: 3.6 GHz to 7 GHz, TX mode, channel 18, vertical & horizontal polarization



Plot 8: 7 GHz to 12.75 GHz, TX mode, channel 18, vertical & horizontal polarization



Plot 9: 12.75 GHz to 18 GHz, TX mode, channel 18, vertical & horizontal polarization



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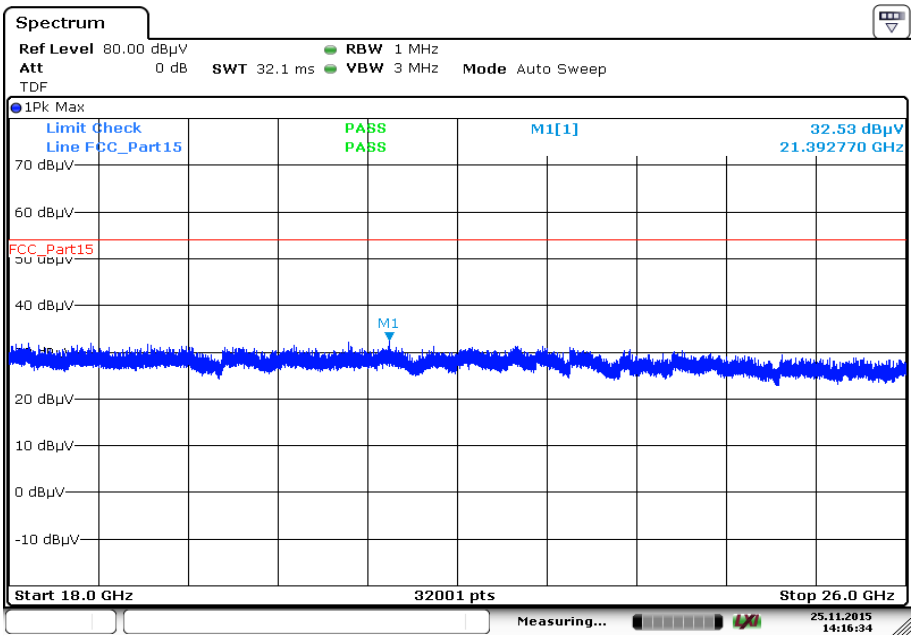
Plot 10: 18 GHz to 26 GHz, TX mode, channel 18, vertical & horizontal polarization



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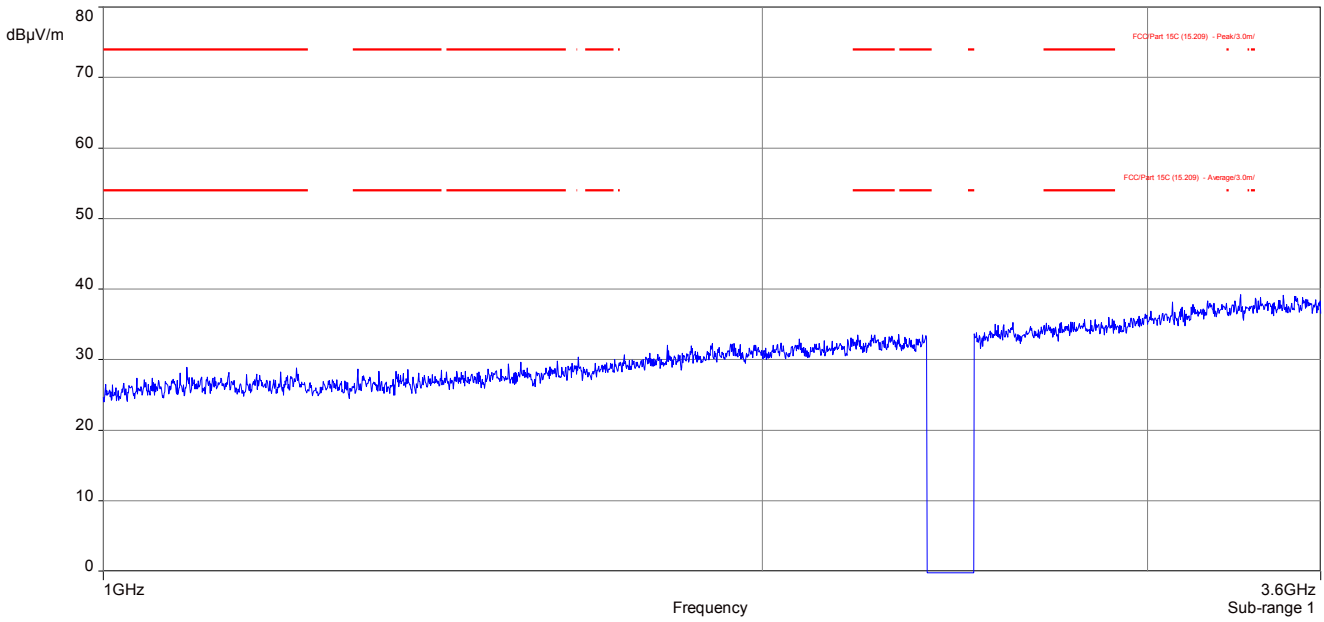
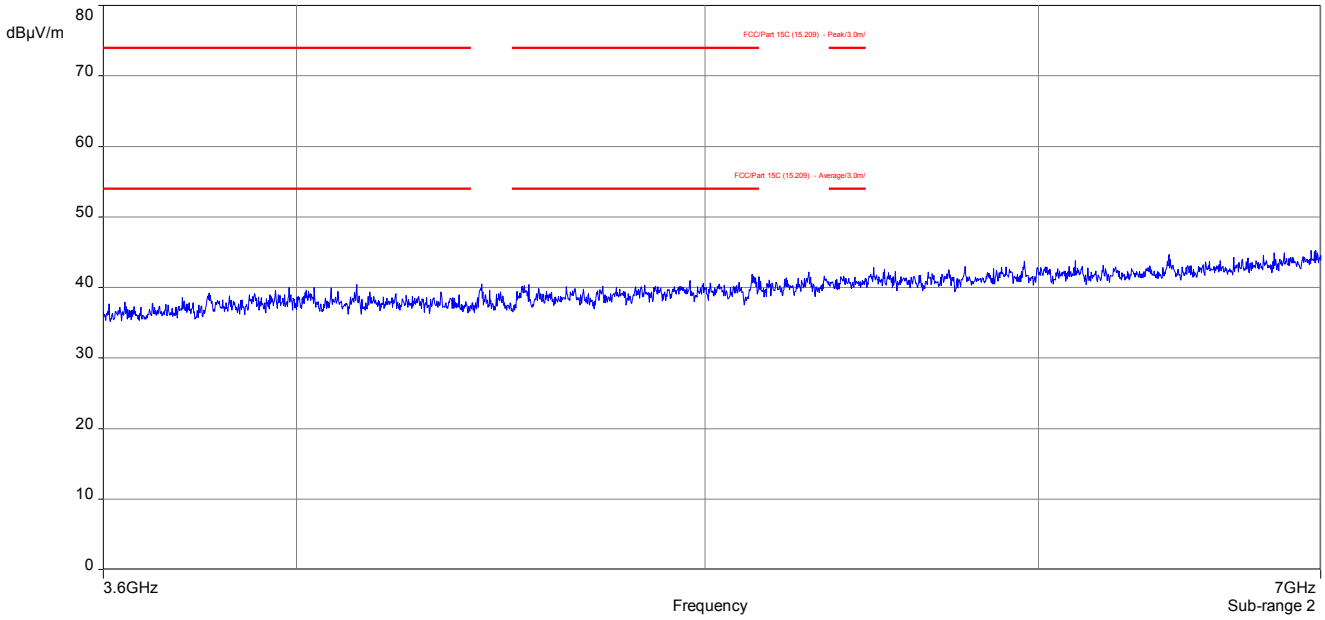
Plot 11: 1 GHz to 3.6 GHz, TX mode, , vertical & horizontal polarization

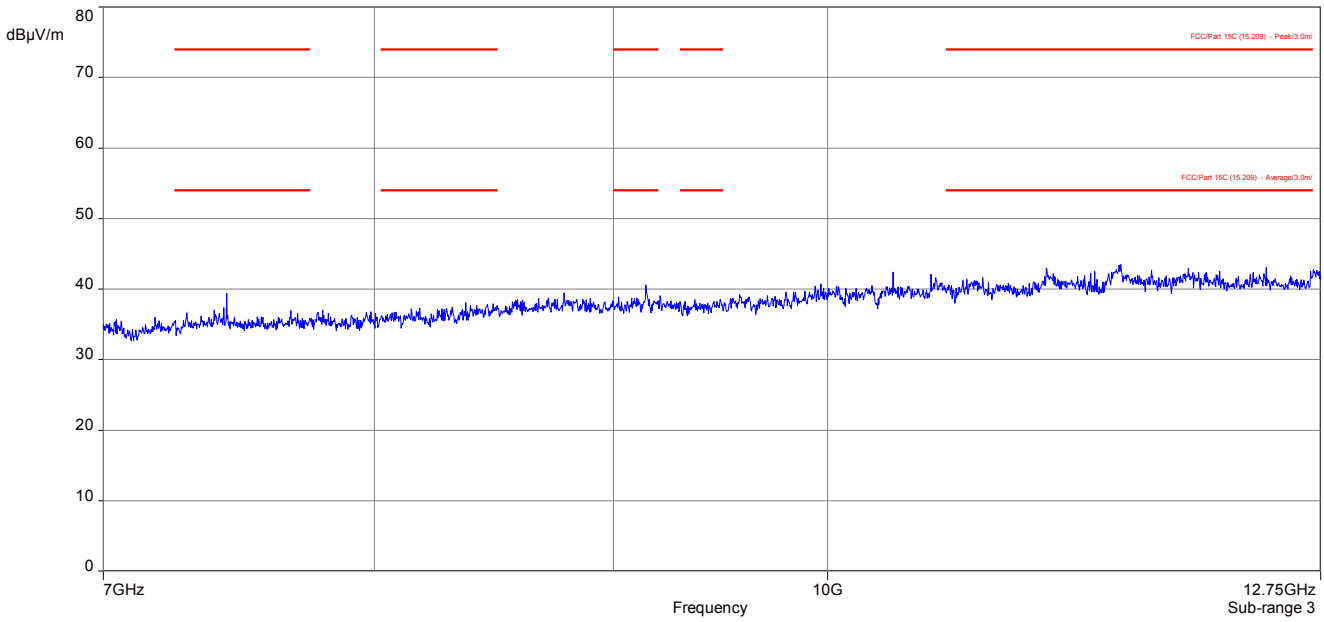


The carrier signal is notched with a 2.4 GHz band rejection filter.

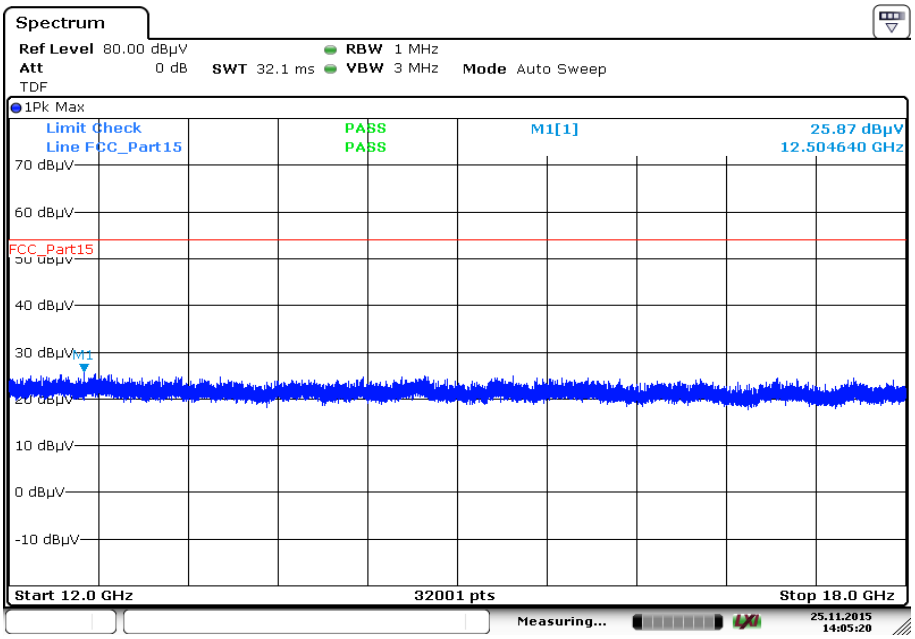
Plot 12: 3.6 GHz to 7 GHz, TX mode, channel 26, vertical & horizontal polarization



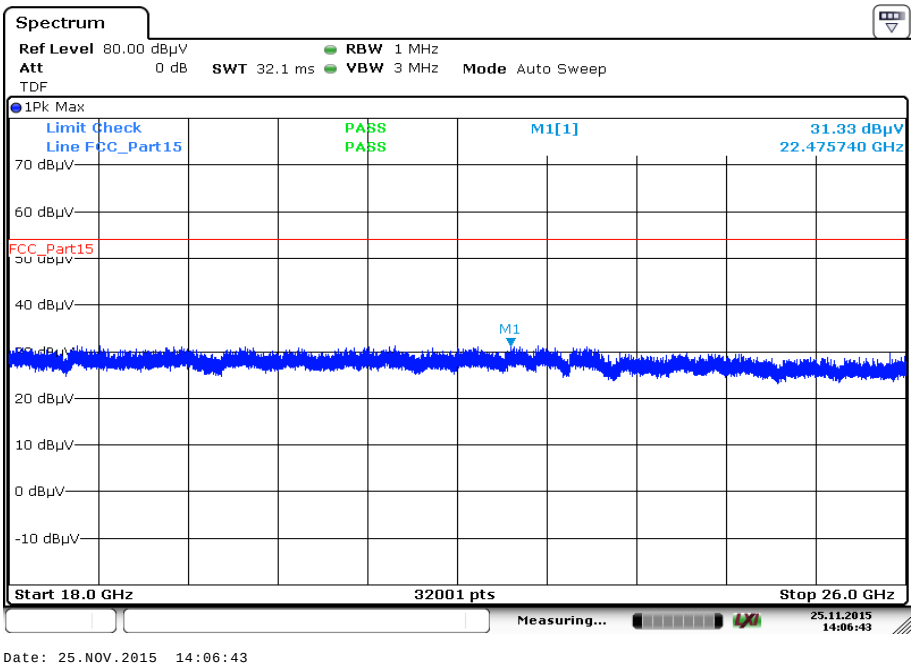
Plot 13: 7 GHz to 12.75 GHz, TX mode, channel 26, vertical & horizontal polarization



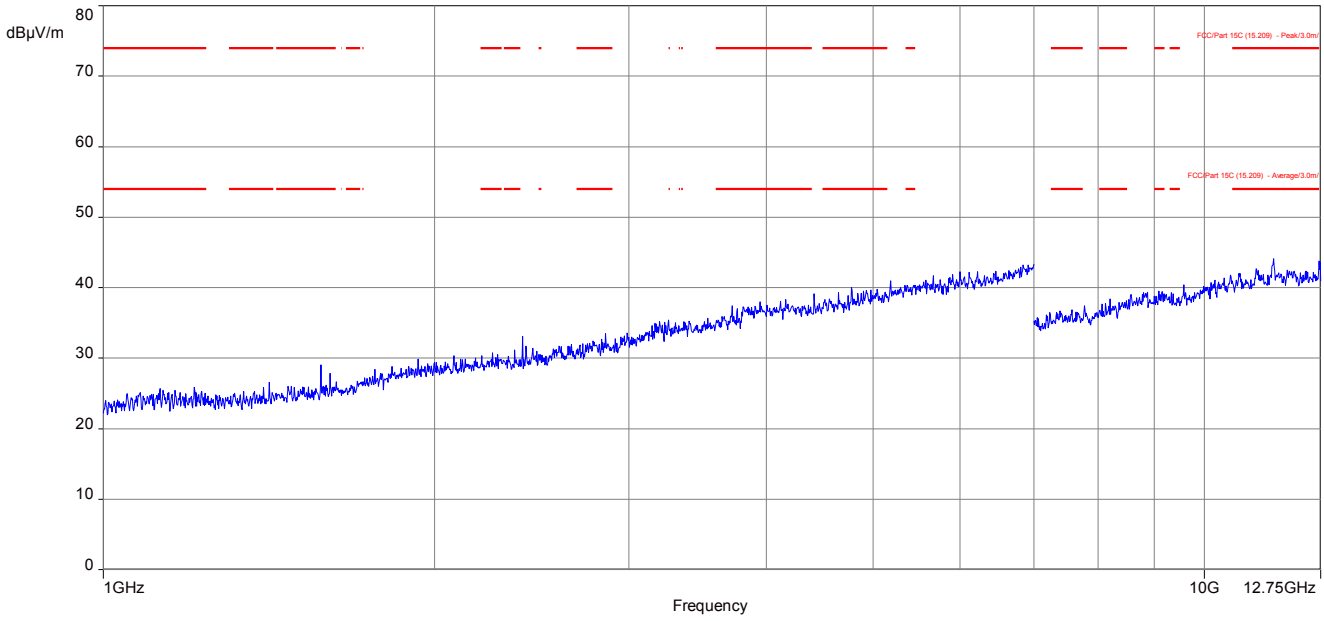
Plot 14: 12.75 GHz to 18 GHz, TX mode, channel 26, vertical & horizontal polarization



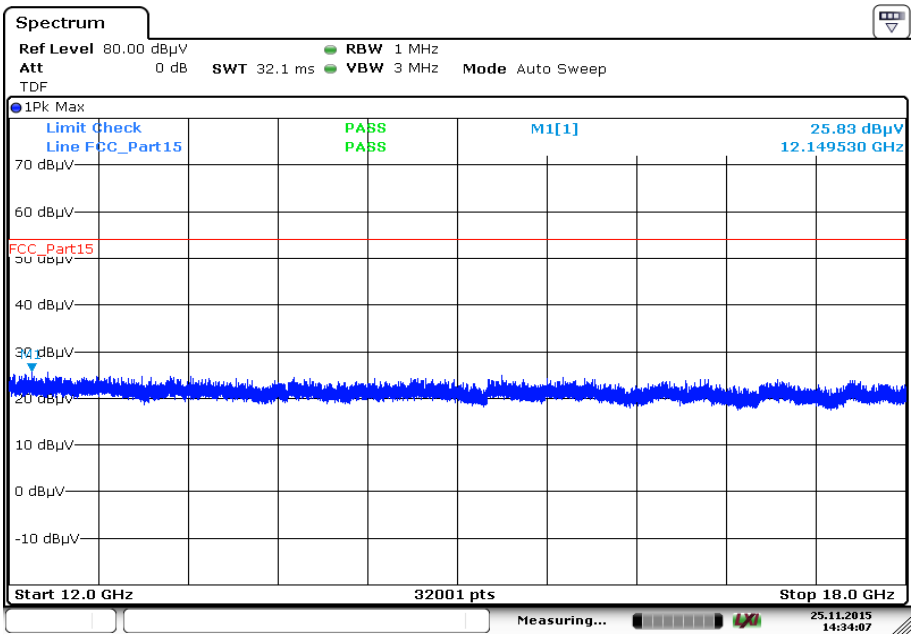
Plot 15: 18 GHz to 26 GHz, TX mode, channel 26, vertical & horizontal polarization



Plot 16: 1 GHz to 12.75 GHz, RX mode, vertical & horizontal polarization



Plot 17: 12.75 GHz to 18 GHz, RX mode, vertical & horizontal polarization



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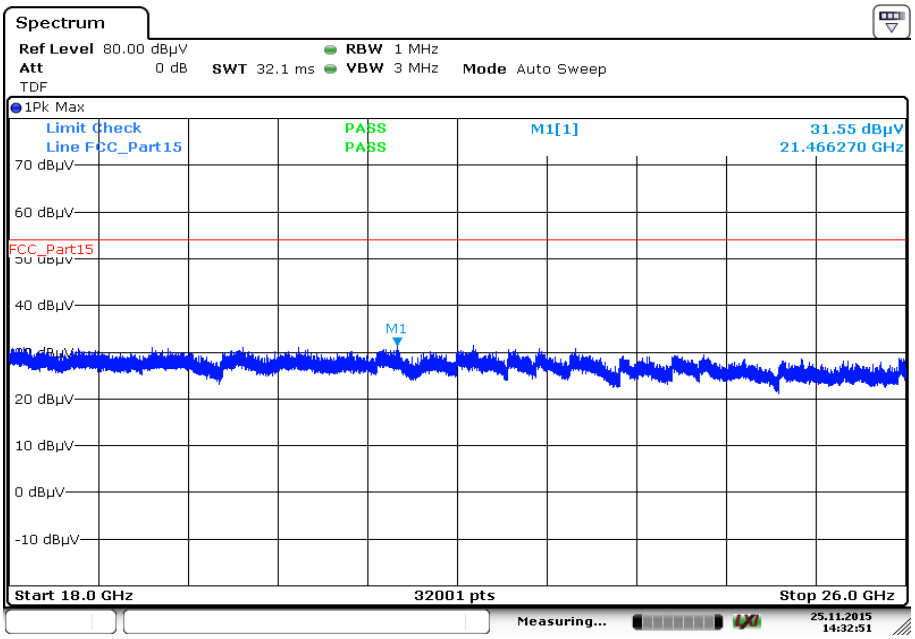
Plot 18: 18 GHz to 26 GHz, RX mode, vertical & horizontal polarization



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12.12 Spurious emissions conducted below 30 MHz (AC conducted)

Description:

Measurement of the conducted spurious emissions in transmit mode below 30 MHz. The EUT is set to single channel mode and the transmit channel is channel 18. This measurement is representative for all channels and modes. If critical peaks are found channel 11 and channel 26 will be measured too. The measurement is performed in the mode with the highest output power. Both power lines, phase and neutral line, are measured. Found peaks are remeasured with average and quasi peak detection to show compliance to the limits.

Measurement parameters	
Detector	Peak - Quasi peak / average
Sweep time	Auto
Resolution bandwidth	F < 150 kHz: 200 Hz F > 150 kHz: 9 kHz
Video bandwidth	F < 150 kHz: 1 kHz F > 150 kHz: 100 kHz
Span:	9 kHz to 30 MHz
Trace mode:	Max hold
Test setup	See sub clause 7.4 A
Measurement uncertainty	See sub clause 9

Limits:

FCC		IC
TX spurious emissions conducted < 30 MHz		
Frequency (MHz)	Quasi-peak (dBµV/m)	Average (dBµV/m)
0.15 – 0.5	66 to 56*	56 to 46*
0.5 – 5	56	46
5 – 30.0	60	50

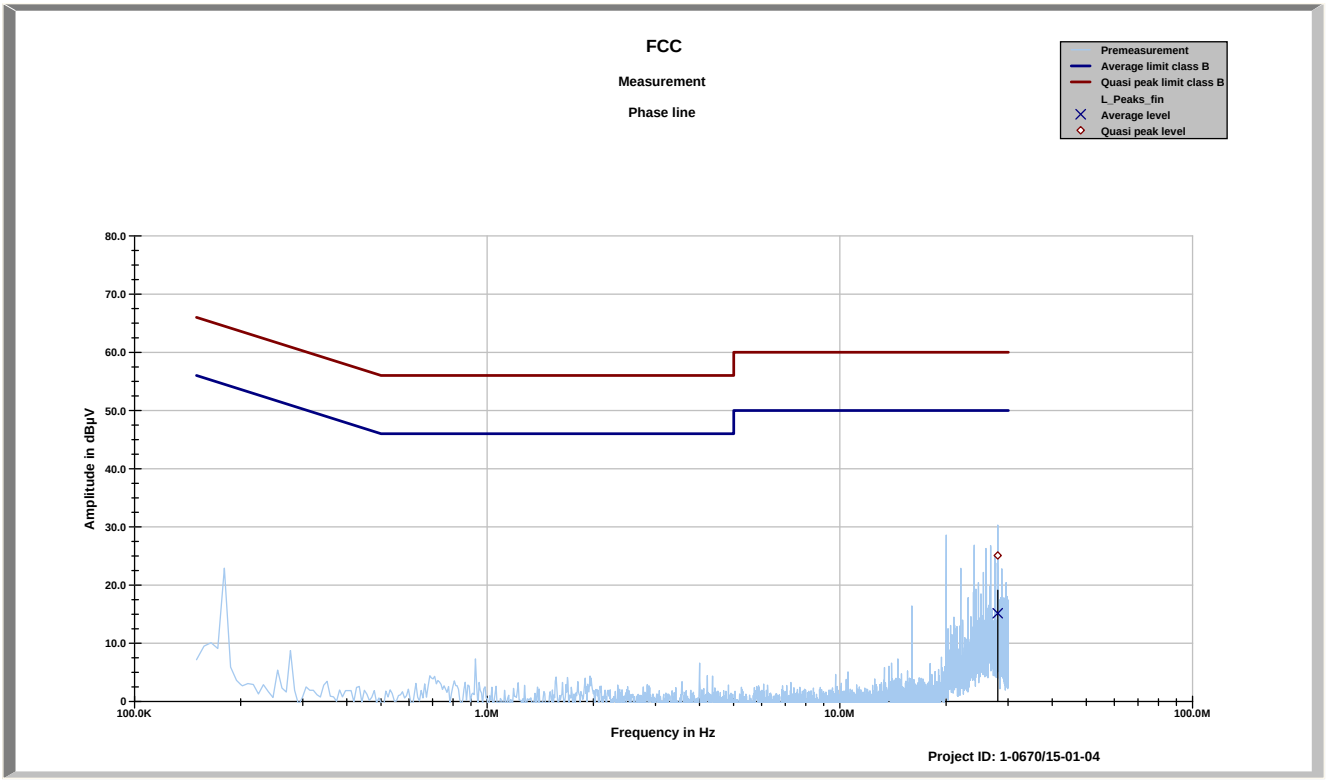
*Decreases with the logarithm of the frequency

Results:

Spurious emissions conducted < 30 MHz [dBµV/m]		
F [MHz]	Detector	Level [dBµV/m]
See result table below plots.		

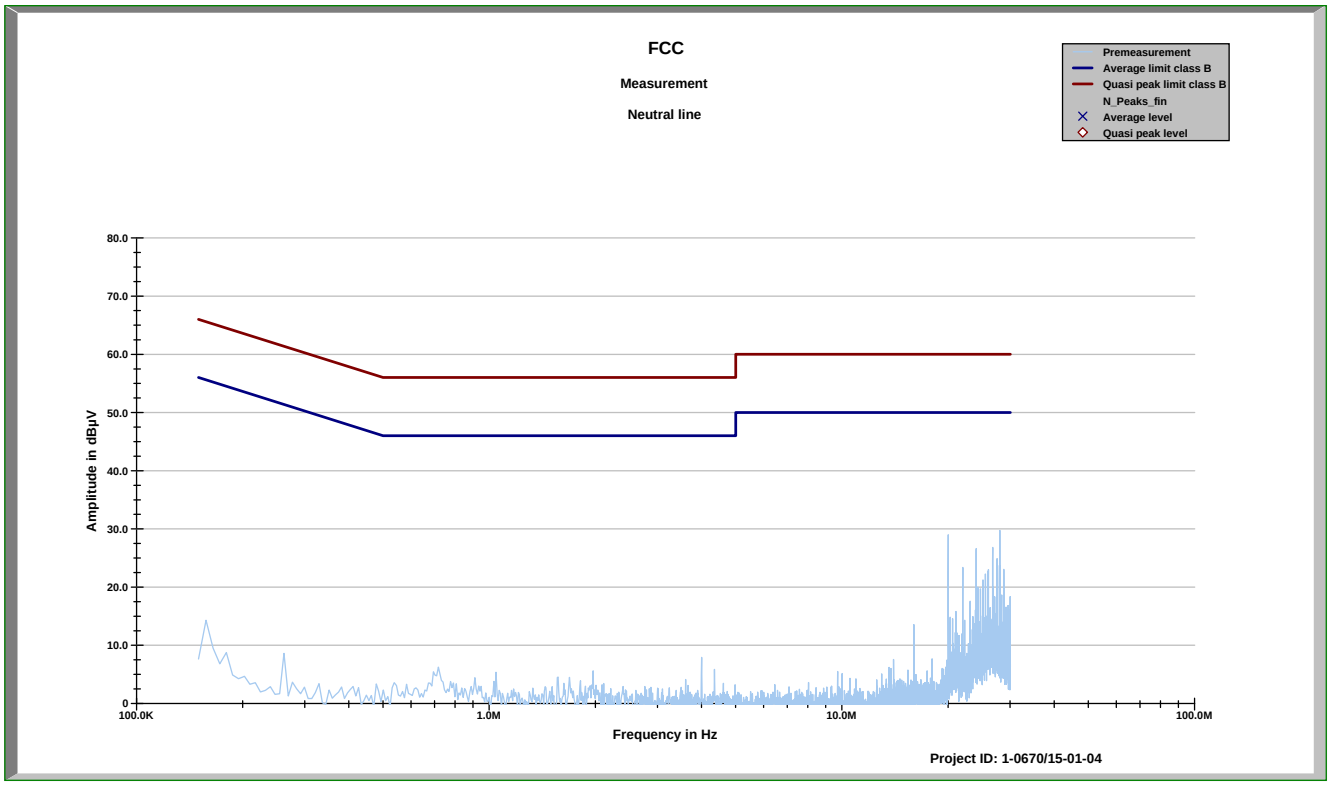
Plots:

Plot 1: 150 kHz to 30 MHz, phase line



Frequency	Quasi peak level	Margin quasi peak	Average level	Margin average
MHz	dBµV	dBµV	dBµV	dBµV
28.006	25.08	34.92	15.16	34.84

Plot 2: 150 kHz to 30 MHz, neutral line



Frequency	Quasi peak level	Margin quasi peak	Average level	Margin average
MHz	dBµV	dBµV	dBµV	dBµV
-/-	-/-	-/-	-/-	-/-

13 Observations

No observations except those reported with the single test cases have been made.

Annex A Document history

Version	Applied changes	Date of release
	Initial release	2015-12-07

Annex B Further information

Glossary

AVG - Average
DUT - Device under test
EMC - Electromagnetic Compatibility
EN - European Standard
EUT - Equipment under test
ETSI - European Telecommunications Standard Institute
FCC - Federal Communication Commission
FCC ID - Company Identifier at FCC
HW - Hardware
IC - Industry Canada
Inv. No. - Inventory number
N/A - Not applicable
PP - Positive peak
QP - Quasi peak
S/N - Serial number
SW - Software
PMN Product marketing name
HMN Host marketing name
HVIN Hardware version identification number
FVIN Firmware version identification number

Annex C Accreditation Certificate

Front side of certificate

DAkkS Deutsche Akkreditierungsstelle

Deutsche Akkreditierungsstelle GmbH

Beliehene gemäß § 8 Absatz 1 AkkStelleG i.V.m. § 1 Absatz 1 AkkStelleGBV
Unterzeichnerin der Multilateralen Abkommen
von EA, ILAC und IAF zur gegenseitigen Anerkennung

Akkreditierung

Die Deutsche Akkreditierungsstelle GmbH bestätigt hiermit, dass das Prüflaboratorium

CETECOM ICT Services GmbH
Untertürkheimer Straße 6-10, 66117 Saarbrücken

die Kompetenz nach DIN EN ISO/IEC 17025:2005 besitzt, Prüfungen in folgenden Bereichen durchzuführen:

Drahtgebundene Kommunikation einschließlich xDSL
VoIP und DECT
Akustik
Funk einschließlich WLAN
Short Range Devices (SRD)
RFID
WiMax und Richtfunk
Mobilfunk (GSM / DCS, Over the Air (OTA) Performance)
Elektromagnetische Verträglichkeit (EMV) einschließlich Automotive
Produktsicherheit
SAR und Hearing Aid Compatibility (HAC)
Umweltsimulation
Smart Card Terminals
Bluetooth
Wi-Fi- Services

Die Akkreditierungsurkunde gilt nur in Verbindung mit dem Bescheid vom 07.03.2014 mit der Akkreditierungsnummer D-PL-12076-01 und ist gültig 17.01.2018. Sie besteht aus diesem Deckblatt, der Rückseite des Deckblatts und der folgenden Anlage mit insgesamt 77 Seiten.

Registrierungsnummer der Urkunde: **D-PL-12076-01-00**

Frankfurt am Main, 07.03.2014

Im Auftrag Dipl.-Ing. (FH) Ralf Egner
Abteilungsleiter

Back side of certificate

Deutsche Akkreditierungsstelle GmbH

Standort Berlin	Standort Frankfurt am Main	Standort Braunschweig
Spittelmarkt 10	Gartenstraße 6	Bundesallee 100
10117 Berlin	60594 Frankfurt am Main	38116 Braunschweig

Die auszugsweise Veröffentlichung der Akkreditierungsurkunde bedarf der vorherigen schriftlichen Zustimmung der Deutsche Akkreditierungsstelle GmbH (DAkkS). Ausgenommen davon ist die separate Weiterverbreitung des Deckblattes durch die umseitig genannte Konformitätsbewertungsstelle in unveränderter Form.

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Die Akkreditierung erfolgte gemäß des Gesetzes über die Akkreditierungsstelle (AkkStelleG) vom 31. Juli 2009 (BGBl. I S. 2625) sowie der Verordnung (EG) Nr. 765/2008 des Europäischen Parlaments und des Rates vom 9. Juli 2008 über die Vorschriften für die Akkreditierung und Marktüberwachung im Zusammenhang mit der Vermarktung von Produkten (Abl. L 218 vom 9. Juli 2008, S. 30).
Die DAkkS ist Unterzeichnerin der Multilateralen Abkommen zur gegenseitigen Anerkennung der European co-operation for Accreditation (EA), des International Accreditation Forum (IAF) und der International Laboratory Accreditation Cooperation (ILAC). Die Unterzeichner dieser Abkommen erkennen ihre Akkreditierungen gegenseitig an.

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EA: www.european-accreditation.org
ILAC: www.ilac.org
IAF: www.iaf.nu

Note:

The current certificate including annex is published on our website (see link below) or may be received from CETECOM ICT Services on request.

https://www.cetecom.com/en/cetecom-group/europe/germany-saarbruecken/accreditations.html